3 Stacked MCP (Multi-Chip Package) FLASH & FLASH & FCRAM

CMOS

64M (×16) FLASH MEMORY & 32M (×16) FLASH MEMORY & 32M (×16) Mobile FCRAM ™

MB84VF5F4F4J1-70

■ FEATURES

- Power supply voltage of 2.7 V to 3.1 V
- High performance

70 ns maximum access time (Flash_1: 64 Mb Falsh)
70 ns maximum access time (Flash_2: 32 Mb Falsh)
65 ns maximum access time (FCRAM: 32 Mb FCRAM)

- Operating Temperature
 - -30 °C to +85 °C
- Package 107-ball FBGA

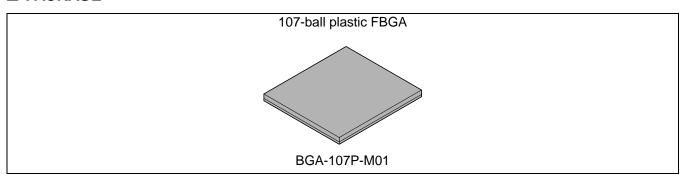
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■ PRODUCT LINEUP

	Flash_1	Flash_2	FCRAM
Supply Voltage (V)	Vccf_1* = 2.7 V to 3.1 V	Vccf_2* = 2.7 V to 3.1 V	Vccr* = 2.7 V to 3.1 V
Max Address Access Time (ns)	70	70	65
Max CE Access Time (ns)	70	70	65
Max OE Access Time (ns)	30	30	40

^{*:} All of Vccf_1, Vccf_2, and Vccr must be the same level when either part is being accessed.

■ PACKAGE





1. FLASH MEMORY_1 & _2

• Simultaneous Read/Write Operations (Dual Bank)

• Flash 1 FlexBank™*1

Bank A: 8 Mbit $(8 \text{ KB} \times 8 \text{ and } 64 \text{ KB} \times 15)$

Bank B : 24 Mbit (64 KB \times 48) Bank C : 24 Mbit (64 KB \times 48)

Bank D: 8 Mbit $(8 \text{ KB} \times 8 \text{ and } 64 \text{ KB} \times 15)$

Flash_2 FlexBank™

Bank A: 4 Mbit (8 KB \times 8 and 64 KB \times 7)

Bank B: 12 Mbit (64 KB \times 24) Bank C: 12 Mbit (64 KB \times 24) Bank D: 4 Mbit (64 KB \times 8)

Two virtual Banks are chosen from the combination of four physical banks.

Host system can program or erase in one bank, and then read immediately and simultaneously from the other bank with zero latency between read and write operations.

Read-while-erase

Read-while-program

• Minimum 100,000 Program/Erase Cycles

Sector Erase Architecture

Sixteen 4 Kword and one hundred twenty-six 32 Kword sectors in word.

Any combination of sectors can be concurrently erased. It also supports full chip erase.

• HiddenROM (HiddenROM) Region

256 byte of HiddenROM, accessible through a new "HiddenROM Enable" command sequence Factory serialized and protected to provide a secure electronic serial number (ESN)

• WP/ACC Input Pin

At V_{L} , allows protection of "outermost" 2×8 Kbytes on both ends of boot sectors, regardless of sector protection/unprotection status

At VIH, allows removal of boot sector protection

At V_{ACC}, increases program performance

• Embedded Erase™ *2 Algorithms

Automatically preprograms and erases the chip or any sector

Embedded Program[™] *2 Algorithms

Automatically writes and verifies data at specified address

• Data Polling and Toggle Bit Feature for Detection of Program or Erase Cycle Completion

Ready/Busy Output (RY/BY_1 or RY/BY_2)

Hardware method for detection of program or erase cycle completion

Automatic Sleep Mode

When addresses remain stable, the device automatically switches itself to low power mode.

- Low Vccf write inhibit ≤ 2.5 V
- Program Suspend/Resume

Suspends the program operation to allow a read in another byte

• Erase Suspend/Resume

Suspends the erase operation to allow a read data and/or program in another sector within the same device

- Please Refer to "MBM29DL64DF" Datasheet in Detailed Function for Flash_1.
- Please Refer to "MBM29DL32BF" Datasheet in Detailed Function for Flash 2.

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2. FCRAMTM *3

• Power Dissipation

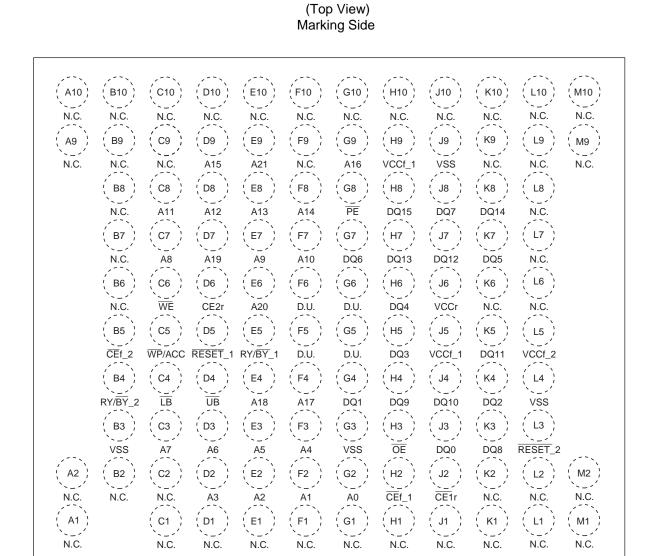
Operating : 25 mA Max Standby : 100 µA Max

• Power Down Mode

Sleep : 10 μA Max NAP : 60 μA Max 8M Partial : 70 μA Max

- Power Down Control by CE2r
- Byte Write Control: LB(DQ7-DQ0), UB(DQ15-DQ8)
- 8 words Address Access Capability
- *1: FlexBank™ is a trademark of Fujitsu Limited, Japan.
- *2: Embedded Erase™ and Embedded Program™ are trademarks of Advanced Micro Devices, Inc.
- *3: FCRAM™ is a trademark of Fujitsu Limited, Japan.

■ PIN ASSIGNMENT

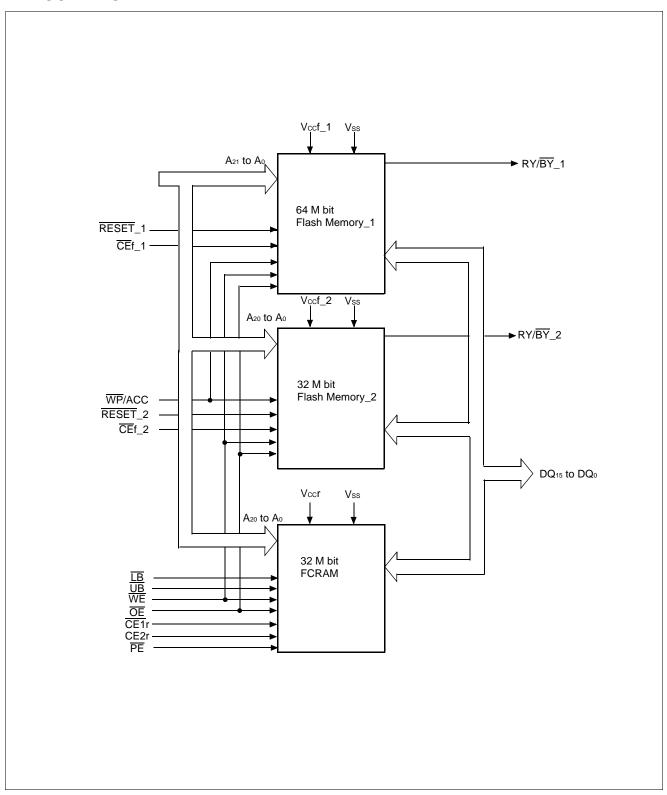


(BGA-107P-M01)

■ PIN DESCRIPTION

Pin name	Input/ Output	Description
A ₂₀ to A ₀	I	Address Inputs (Common)
A ₂₁	I	Address Input (Flash_1)
DQ ₁₅ to DQ ₀	I/O	Data Inputs/Outputs (Common)
CEf_1	I	Chip Enable (Flash_1)
CEf_2	I	Chip Enable (Flash_2)
CE1r	I	Chip Enable (FCRAM)
CE2r	I	Chip Enable (FCRAM)
ŌĒ	I	Output Enable (Common)
WE	I	Write Enable (Common)
RY/BY_1	0	Ready/Busy Output (Flash_1) Open Drain Output
RY/BY_2	0	Ready/Busy Output (Flash_2) Open Drain Output
ŪB	I	Upper Byte Control (FCRAM)
<u>LΒ</u>	I	Lower Byte Control (FCRAM)
RESET_1	I	Hardware Reset Pin/Sector Protection Unlock (Flash_1)
RESET_2	I	Hardware Reset Pin/Sector Protection Unlock (Flash_2)
WP/ACC	I	Write Protect / Acceleration (Flash_1 & Flash_2)
PE	I	Partial Enable (FCRAM)
N.C.	_	No Internal Connection
D.U.	_	Don't Use
Vss	Power	Device Ground (Common)
Vccf_1	Power	Device Power Supply (Flash_1)
Vccf_2	Power	Device Power Supply (Flash_2)
Vccr	Power	Device Power Supply (FCRAM)

■ BLOCK DIAGRAM



■ DEVICE BUS OPERATIONS

Operation*1, *2	CEf_1	CEf_2	CE1r	CE2r	OE	WE	LB	UB	PE	A ₂₀ to A ₀	DQ7 to	DQ ₁₅ to DQ ₈	RESET_1	RESET_2	WP/ ACC *12
Full Standby	Н	Н	Н	Н	Х	Х	Χ	Х	Н	Х	High-Z	High-Z	Н	Н	Х
	Н	Н	L		Н	Н	Χ	Х		X*10					
Output Disable *3	L	Н	Н	Н	Н	Н	Х	Х	Н	Х	High-Z	High-Z	Н	Н	Х
	Н	L	Н					,		,					
Read from Flash_1 *4	L	Н	Н	Н	L	Н	Х	Х	Н	Valid	D оит	D оит	Н	Н	Х
Read from Flash_2 *4	Н	L	Н	Н	L	Н	Х	Х	Н	Valid	D оит	D оит	Н	Н	х
Write to Flash _1	L	Н	Н	Н	Н	L	Χ	Х	Н	Valid	Din	Din	Н	Н	Х
Write to Flash_2	Η	┙	Н	Н	Н	L	Χ	Χ	Н	Valid	DIN	Din	Н	Н	Х
Read from FCRAM *5	Н	Н	L	Н	L	Н	L*9	L*9	Н	Valid	Dоит	D оит	Н	Н	Х
							L	L			Din	Din			
Write to FCRAM	Н	Н	L	Н	Н	L	Н	L	Н	Valid	High-Z	Din	Н	Н	Х
							L	Н			DIN	High-Z			
Flash_1 Temporary Sector Group Unprotection *6	X	Х	X	X	х	х	Х	х	х	x	х	X	VıD	X	х
Flash_ 2 Temporary Sector Group Unprotection*6	Х	Х	x	x	х	х	х	х	х	х	Х	Х	Х	VID	х
Flash_1 Hardware Reset	Х	Х	Н	Н	Х	Х	Х	Х	Х	Х	High-Z	High-Z	L	Х	Х
Flash_2 Hardware Reset	Х	Х	Н	Н	Х	Х	Х	Х	Х	Х	High-Z	High-Z	Х	L	Х
Flash_1 or 2 Boot Block Sector Write Protection	Х	X	Х	Х	х	Х	X	X	X	Х	х	х	Х	Х	L
FCRAM Power Down Program	Н	Н	Н	Н	Х	Х	Х	Х	L	Valid *11	High-Z	High-Z	Н	Н	Х
FCRAM No Read *7	Н	Н	L	Н	L	Н	Н	Н	Н	Valid	High-Z	High-Z	Н	Н	Х
FCRAM Power Down *8	Х	Х	Х	L	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х

Legend: $L = V_{IL}$, $H = V_{IH}$, $X = V_{IL}$ or V_{IH} . See DC Characteristics for voltage levels.

- *1 : Other operations except for indicated this column are inhibited.
- *2 : Do not apply for a following state two or more on the same time; 1) $\overline{CEf}_1 = V_{\text{IL}}$, 2) $\overline{CEf}_2 = V_{\text{IL}}$, 3) $\overline{CE1}r = V_{\text{IL}}$ and $CE2r = V_{\text{IH}}$
- *3 : FCRAM Output Disable condition should not be kept longer than 1µs.
- *4 : WE can be V_{IL} if OE is V_{IL}, OE at V_{IH} initiates the write operations.
- *6: It is also used for the extended sector group protections.
- *7 : The FCRAM Power Down Program can be performed one time after compliance of Power-UP timings and it should not be re-programmed after regular Read or Write.
- *8 : FCRAM Power Down mode can be entered from Standby state and all DQ pins are in High-Z state. IPDr current and data retention depends on the selection of Power Down Program.
- *9 : Either or both \overline{LB} and \overline{UB} must be Low for FCRAM Read Operation.
- *10 : Can be either V_{IL} or V_{IH} but must be valid before Read or Write.
- *11 : See "1. FCRAM Power Down Program Key Table" in "■32M FCRAM CHARACTERISTICS for MCP".
- *12 : Protect " outer most " $2 \times 8 K$ bytes (4 words) on both ends of the boot block sectors.

■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rat	ing	l lmi4
Farameter	Symbol	Min	Max	Unit
Storage Temperature	Tstg	<i>–</i> 55	+125	°C
Ambient Temperature with Power Applied	TA	-30	+85	°C
N/ II			Vccf_1 + 0.3	V
Voltage with Respect to Ground All pins except RESET_1 or RESET_2, WP/ACC *1	VIN, VOUT	-0.3	Vccf_2 + 0.3	V
except REGET_1 of REGET_2, wit //Reg			Vccr + 0.3	V
Vccf_1/Vccf_2/Vccr Supply *1	Vccf_1,Vccf_2, Vccr	-0.3	+3.3	V
RESET_1 or RESET_2 *2	Vin	-0.5	+ 13.0	V
WP/ACC *3	Vin	-0.5	+10.5	V

- *1 : Minimum DC voltage on input or I/O pins is -0.3 V. During voltage transitions, input or I/O pins may undershoot Vss to -1.0 V for periods of up to 20 ns. Maximum DC voltage on input or I/O pins is $Vccf_1 + 0.3$ V or $Vccf_2 + 0.3$ V or $Vccf_1 + 0.3$ V. During voltage transitions, input or I/O pins may overshoot to $Vccf_1 + 2.0$ V or $Vccf_2 + 2.0$ V or $Vccf_1 + 2.0$ V for periods of up to 20 ns.
- *2 : Minimum DC input voltage on RESET_1 or RESET_2 pin is -0.5 V. During voltage transitions RESET_1 or RESET_2 pins may undershoot Vss to -2.0 V for periods of up to 20 ns.

 Voltage difference between input and supply voltage (VIN-Vccf_1 or Vccf_2) does not exceed +9.0 V.

 Maximum DC input voltage on RESET_1 or RESET_2 pins is +13.0 V which may overshoot to +14.0 V for periods of up to 20 ns.
- *3 : Minimum DC input voltage on WP/ACC pin is -0.5 V. During voltage transitions, WP/ACC pin may undershoot Vss to -2.0 V for periods of up to 20 ns. Maximum DC input voltage on WP/ACC pin is +10.5 V which may overshoot to +12.0 V for periods of up to 20 ns, when Vccf_1 or Vccf_2 is applied.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value		Unit
Farameter	Symbol	Min	Max	Ollic
Ambient Temperature	TA	-30	+85	°C
Vccf_1/Vccf_2/Vccr Supply Voltages	Vccf_1,Vccf_2,Vccr	er +2.7 +3.1		

Note: Operating ranges define those limits between which the functionality of the device is guaranteed.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

■ ELECTRICAL CHARACTERISTICS

1. DC Characteristics

Doromotor	Symbol	Candition		Value		Unit	
Parameter	Symbol	Condition	is	Min	Тур	Max	Unit
Input Leakage Current	lu	Vin = Vss to Vccf_1,Vccr	-1.0	_	+1.0	mA	
Output Leakage Current	ILO	Vout = Vss to Vccf_1,Vccr		-1.0	_	+1.0	mA
RESET Inputs Leakage Current	Інт	Vccf = Vccf Max, RESET = 12.5 V		_		35	μA
Flash_1 Vcc Active Current (Read) *1	Icc ₁ f_1	<u>CEf_</u> 1 = V _{IL} , <u>OE</u> = V _{IH}	tcycle = 5 MHz tcycle = 1 MHz			18 4	mA mA
Flash_1 Vcc Active Current (Program/Erase) *2	lcc2f_1	Œf_1 = Vı∟, ŌĒ = Vıн		_	_	30	mA
Flash_1 Vcc Active Current (Read-While-Program) *5	lcc₃f_1	Œf_1 = Vı∟, ŌE = Vıн		_	_	48	mA
Flash_1 Vcc Active Current (Read-While-Erase) *5	Icc4f_1	CEf_1 = V _I L, OE = V _I H		_	_	48	mA
Flash_1 Vcc Active Current (Erase-Suspend-Program)	lcc₅f_1	CEf _1= VIL, OE = VIH		_	_	30	mA
Flash_2 Vcc Active Current	Icc ₁ f_2	<u>CE</u> f_2 = V⊩,	tcycle = 5 MHz	_	_	18	mA
(Read) *1	10011_2	$\overline{OE} = V_{IH}$ $t_{CYCLE} = 1 \text{ MHz}$		_	_	4	1117 (
Flash_2 Vcc Active Current (Program/Erase) *2	lcc2f_2	$\overline{CE}_2 = V_{IL}, \overline{OE} = V_{IH}$		_	_	30	mA
Flash_2 Vcc Active Current (Read-While-Program) *5	lcc3f_2	CE_2 = V _{IL} , OE = V _{IH}			_	48	mA
Flash_2 Vcc Active Current (Read-While-Erase) *5	Icc4f_2	CE_2 = VIL, OE = VIH		_	_	48	mA
Flash_2 Vcc Active Current (Erase-Suspend-Program)	lcc₅f_2	CE_2 = V _{IL} , OE = V _{IH}		_	_	35	mA
WP/ACC Acceleration Program Current	Iacc	Vccf = Vccf Max, WP/ACC = Vacc Max		_	_	20	mA
		Vccr = Vccr Max, CE1r = V _I L, CE2r = V _I H,	t _{RC} / t _{WC} = Min	_	_	25	
FCRAM Vcc Active Current	lcc1r	VIN = VIH OF VIL, IOUT = 0mA	trc / twc = 1 ms	_	_	3	mA
Flash Vcc Standby Current	I _{SB1} f			_	1 * ⁷	5 * ⁷	μΑ
Flash Vcc Standby Current (RESET)	I _{SB2} f	$\frac{\text{Vccf} = \text{Vccf Max, } \overline{\text{RESET}} = \text{Vss} \pm 0.3 \text{ V,}}{\overline{\text{WP}}/\text{ACC} = \text{Vccf} \pm 0.3 \text{ V}}$		_	1 * ⁷	5 * ⁷	μA
Flash Vcc Current (Automatic Sleep Mode) *3	Isasf			_	1 *7	5 * ⁷	μΑ

(Continued)

Parameter	Symbol	Conditions			Unit		
Parameter	Symbol	Conditions		Min	Тур	Max	Onit
FCRAM Vcc Standby Current	I _{SB1} r	$V_{CET} = V_{CET} Max$, $\overline{CE1}r \ge V_{CET} - CE2r \ge V_{CET} - 0.2V$, $V_{IN} \le 0.2 \text{ V or } V_{CET} - 0.2 \text{ V}$					μΑ
	IPDST	Vccr = Vccr Max,	Sleep	_	_	10	μA
FCRAM Vcc Power Down Current	IPDN	CE1r ≥ Vccr – 0.2V, CE2r ≤ 0.2V,	NAP		_	60	μA
	I _{PD8} r	V_{IN} Cycle time = trc Min	8M Partial	_	_	70	μA
Input Low Level	VIL	_		-0.3	_	0.5	V
Input High Level	Vıн	_	2.2	_	Vcc+ 0.3 *6	V	
Voltage for Sector Protection, and Temporary Sector Unprotection (RESET) *4	VID	_	11.5	_	12.5	V	
Voltage for WP/ACC Sector Protection/Unprotection and Program Acceleration *4	Vacc	_	_				V
Output Low Voltage Level	Volf	Vccf = Vccf Min, IoL = 4.0 mA	Flash			0.45	V
Odiput Low Voltage Level	Volr	Vccr = Vccr Min, IoL = 1.0 mA	FCRAM	_		0.4	V
Output High Voltage Level	Vонf	Vccf = Vccf Min, IoH = -0.1 mA	Flash	Vccf- 0.4	_	_	٧
	Vон r	Vccr = Vccr Min, Iон = -0.5mA	FCRAM	2.2	_	_	V
Flash Low Vccf Lock-Out Voltage	Vlko	_		2.3	2.4	2.5	V

Legend: Flash means Flash_1 or Flash_2, Vccf means Vccf_1 or Vccf_2, Vssf means Vssf_1 or Vssf_2, \overline{CE}f means \overline{CE}f_1 or \overline{CE}f_2, \overline{RESET} means \overline{RESET}_1 or \overline{RESET}_2

^{*1:} The loc current listed includes both the DC operating current and the frequency dependent component.

^{*2:} Icc active while Embedded Algorithm (program or erase) is in progress.

^{*3:} Automatic sleep mode enables the low power mode when address remains stable for 150 ns.

^{*4:} Applicable for only Vccf applying.

^{*5:} Embedded Alogorithm (program or erase) is in progress. (@5 MHz)

^{*6:} Vcc indicates lower of Vccf_1 or Vccf_2 or Vccr.

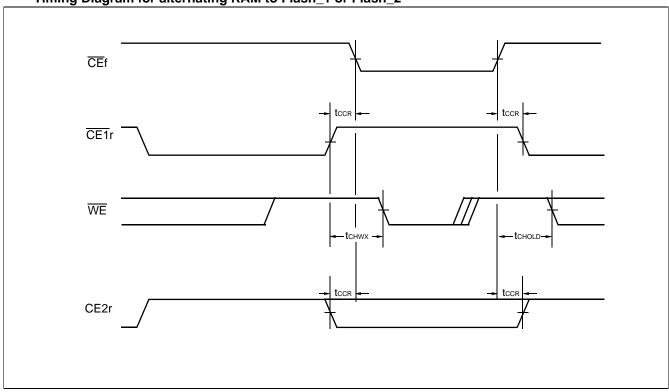
^{*7:} Actual Standby Current is twice of what is indicated in the table, due to two Flash memory chips embedment within one device.

2. AC Characteristics

• CE Timing

Parameter	Syn	nbol	Condition	Va	Unit	
Faranietei	JEDEC	Standard	Condition	Min	Max	Oilit
CE Recover Time	_	t ccr	_	0	_	ns
CE Hold Time	_	t chold	_	3	_	ns
CE1r, High to WE Invalid time for Standby Entry	_	t chwx	_	10	_	ns

• Timing Diagram for alternating RAM to Flash_1 or Flash_2



• Flash_1 Characteristics

Please refer to "■64M FLASH MEMORY CHARACTERISTICS for MCP" part. In this part, Flash means Flash_1, Vccf means Vccf_1, Vssf means Vssf_1, \overline{CE}f means \overline{CE}f_1, \overline{RESET} means \overline{RESET}_1

• Flash 2 Characteristics

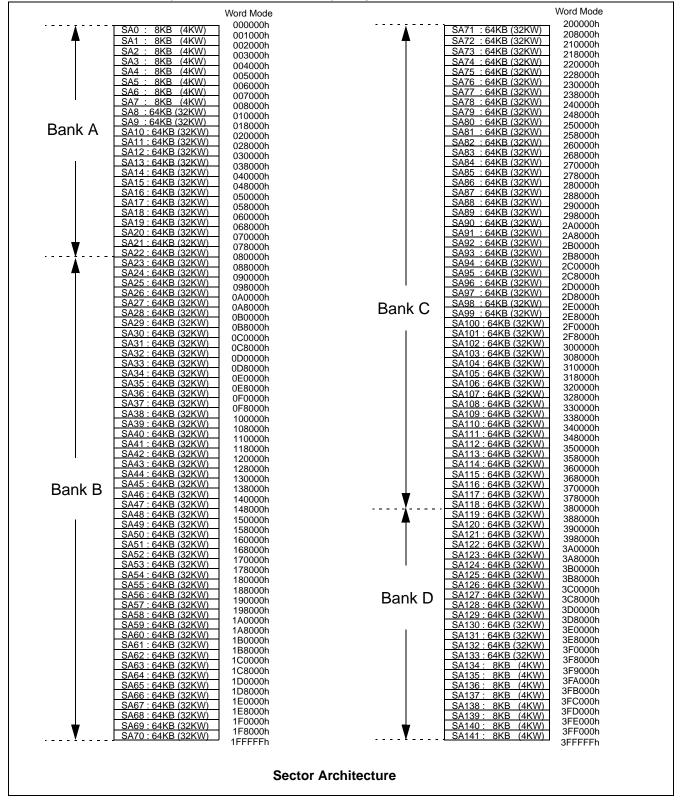
Please refer to "■32M FLASH MEMORY CHARACTERISTICS for MCP" part. In this part, Flash means Flash_2, Vccf means Vccf_2, Vssf means Vssf_2, CEf means CEf_2, RESET means RESET_2

• FCRAM Characteristics

Please refer to "■32M FCRAM CHARACTERISTICS for MCP" part.

■ 64M FLASH MEMORY CHARACTERISTICS for MCP

- Flexible Sector-erase Architecture on Flash Memory
 - Sixteen 4K words, and one hundred twenty-six 32K words.
 - Individual-sector, multiple-sector, or bulk-erase capability.



FlexBank™ Architecture Table

Bank		Bank 1	Bank 2					
Splits	Volume	Combination	Volume	Combination				
1	8 Mbit	Bank A	56 Mbit	Remainder (Bank B, C, D)				
2	24 Mbit	Bank B	40 Mbit	Remainder (Bank A, C, D)				
3	24 Mbit	Bank C	40 Mbit	Remainder (Bank A, B, D)				
4	8 Mbit	Bank D	56 Mbit	Remainder (Bank A, B, C)				

Example of Virtual Banks Combination Table

Bank		Ba	nk 1	Bank 2					
Splits	Volume	Combination	Sector Size	Volume	Combination	Sector Size			
					Bank B				
			8 × 8 Kbyte/4 Kword		+	8 × 8 Kbyte/4 Kword			
1	8 Mbit	Bank A	+	56 Mbit	Bank C	+			
			15 × 64 Kbyte/32 Kword		+	111 × 64 Kbyte/32 Kword			
					Bank D				
		Bank A	16 × 8 Kbyte/4 Kword		Bank B				
2	16 Mbit	+	+	48 Mbit	+	96 × 64 Kbyte/32 Kword			
		Bank D	30 × 64 Kbyte/32 Kword		Bank C				
					Bank A				
					+	16 × 8 Kbyte/4 Kword			
3	24 Mbit	Bank B	48 × 64 Kbyte/32 Kword	40 Mbit	Bank C	+			
					+	78 × 64 Kbyte/32 Kword			
					Bank D				
		Bank A	8 × 8 Kbyte/4 Kword		Bank C	8 × 8 Kbyte/4 Kword			
4	32 Mbit	+	+	32 Mbit	+	+			
		Bank B	63 × 64 Kbyte/32 Kword		Bank D	63 × 64 Kbyte/32 Kword			

Note: When multiple sector erase over several banks is operated, the system cannot read out of the bank to which a sector being erased belongs. For example, suppose that erasing is taking place at both Bank A and Bank B, neither Bank A nor Bank B is read out (they would output the sequence flag once they were selected.)

Meanwhile the system would get to read from either Bank C or Bank D.

Simultaneous Operation Table

Case	Bank 1 Status	Bank 2 Status			
1	Read mode	Read mode			
2	Read mode	Autoselect mode			
3	Read mode	Program mode			
4	Read mode	Erase mode *			
5	Autoselect mode	Read mode			
6	Program mode	Read mode			
7	Erase mode *	Read mode			

^{*:} By writing erase suspend command on the bank address of sector being erased, the erase operation gets suspended so that it enables reading from or programming the remaining sectors.

Note: Bank 1 and Bank 2 are divided for the sake of convenience at Simultaneous Operation. Actually, the Bank consists of 4 banks, Bank A, Bank B, Bank C and Bank D. Bank Address (BA) meant to specify each of the Banks.

Sector Address Table

					S	ector /	Addres	SS				Address Range
Bank	Sector	Ban	k Add	ress								Word Modo
		A 21	A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Word Mode
	SA0	0	0	0	0	0	0	0	0	0	0	000000h to 000FFFh
	SA1	0	0	0	0	0	0	0	0	0	1	001000h to 001FFFh
	SA2	0	0	0	0	0	0	0	0	1	0	002000h to 002FFFh
	SA3	0	0	0	0	0	0	0	0	1	1	003000h to 003FFFh
	SA4	0	0	0	0	0	0	0	1	0	0	004000h to 004FFFh
	SA5	0	0	0	0	0	0	0	1	0	1	005000h to 005FFFh
	SA6	0	0	0	0	0	0	0	1	1	0	006000h to 006FFFh
	SA7	0	0	0	0	0	0	0	1	1	1	007000h to 007FFFh
	SA8	0	0	0	0	0	0	1	Х	Х	Х	008000h to 00FFFFh
	SA9	0	0	0	0	0	1	0	Х	Х	Х	010000h to 017FFFh
	SA10	0	0	0	0	0	1	1	Х	Х	Х	018000h to 01FFFFh
Bank A	SA11	0	0	0	0	1	0	0	Х	Х	Х	020000h to 027FFFh
	SA12	0	0	0	0	1	0	1	Х	Х	Х	028000h to 02FFFFh
	SA13	0	0	0	0	1	1	0	Х	Х	Х	030000h to 037FFFh
	SA14	0	0	0	0	1	1	1	Х	Х	Х	038000h to 03FFFFh
	SA15	0	0	0	1	0	0	0	Х	Х	Х	040000h to 047FFFh
	SA16	0	0	0	1	0	0	1	Х	Х	Х	048000h to 04FFFFh
	SA17	0	0	0	1	0	1	0	Х	Х	Х	050000h to 057FFFh
	SA18	0	0	0	1	0	1	1	Х	Х	Х	058000h to 05FFFFh
	SA19	0	0	0	1	1	0	0	Х	Х	Х	060000h to 067FFFh
	SA20	0	0	0	1	1	0	1	Х	Х	Х	068000h to 06FFFFh
	SA21	0	0	0	1	1	1	0	Х	Х	Х	070000h to 077FFFh
	SA22	0	0	0	1	1	1	1	Х	Х	Х	078000h to 07FFFFh

					S	ector /	Addres	SS				Address Range
Bank	Sector	Ban	k Add	ress								_
		A 21	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Word Mode
	SA23	0	0	1	0	0	0	0	Х	Х	Х	080000h to 087FFFh
	SA24	0	0	1	0	0	0	1	Х	Х	Х	088000h to 08FFFFh
	SA25	0	0	1	0	0	1	0	Х	Х	Х	090000h to 097FFFh
	SA26	0	0	1	0	0	1	1	Х	Х	Х	098000h to 09FFFFh
	SA27	0	0	1	0	1	0	0	Х	Х	Х	0A0000h to 0A7FFFh
	SA28	0	0	1	0	1	0	1	Х	Х	Х	0A8000h to 0AFFFFh
	SA29	0	0	1	0	1	1	0	Х	Х	Х	0B0000h to 0B7FFFh
	SA30	0	0	1	0	1	1	1	Х	Х	Х	0B8000h to 0BFFFFh
	SA31	0	0	1	1	0	0	0	Х	Х	Х	0C0000h to 0C7FFFh
	SA32	0	0	1	1	0	0	1	Х	Х	Х	0C8000h to 0CFFFFh
	SA33	0	0	1	1	0	1	0	Х	Х	Х	0D0000h to 0D7FFFh
	SA34	0	0	1	1	0	1	1	Х	Х	Х	0D8000h to 0DFFFFh
	SA35	0	0	1	1	1	0	0	Х	Х	Х	0E0000h to 0E7FFFh
	SA36	0	0	1	1	1	0	1	Х	Х	Х	0E8000h to 0EFFFFh
	SA37	0	0	1	1	1	1	0	Х	Х	Х	0F0000h to 0F7FFFh
	SA38	0	0	1	1	1	1	1	Х	Х	Х	0F8000h to 0FFFFFh
	SA39	0	1	0	0	0	0	0	Х	Х	Х	100000h to 107FFFh
	SA40	0	1	0	0	0	0	1	Х	Х	Х	108000h to 10FFFFh
	SA41	0	1	0	0	0	1	0	Х	Х	Х	110000h to 117FFFh
	SA42	0	1	0	0	0	1	1	Х	Х	Х	118000h to 11FFFFh
	SA43	0	1	0	0	1	0	0	Х	Х	Х	120000h to 127FFFh
	SA44	0	1	0	0	1	0	1	Х	Х	Х	128000h to 12FFFFh
	SA45	0	1	0	0	1	1	0	Х	Х	Х	130000h to 137FFFh
	SA46	0	1	0	0	1	1	1	X	X	X	138000h to 13FFFFh
Bank B	SA47	0	1	0	1	0	0	0	Х	Х	Х	140000h to 147FFFh
	SA48	0	1	0	1	0	0	1	Х	Х	Х	148000h to 14FFFFh
	SA49	0	1	0	1	0	1	0	X	X	X	150000h to 157FFFh
	SA50	0	1	0	1	0	1	1	X	X	X	158000h to 15FFFFh
	SA51	0	1	0	1	1	0	0	Х	Х	Х	160000h to 167FFFh
	SA52	0	1	0	1	1	0	1	X	X	X	168000h to 16FFFFh
	SA53	0	1	0	1	1	1	0	Х	Х	Х	170000h to 177FFFh
	SA54	0	1	0	1	1	1	1	Х	Х	Х	178000h to 17FFFFh
	SA55	0	1	1	0	0	0	0	X	X	X	180000h to 187FFFh
	SA56	0	1	1	0	0	0	1	X	X	X	188000h to 18FFFFh
	SA57	0	1	1	0	0	1	0	X	X	X	190000h to 197FFFh
	SA58	0	1	1	0	0	1	1	X	X	X	198000h to 19FFFFh
	SA59	0	1	1	0	1	0	0	X	X	X	1A0000h to 1A7FFFh
	SA60	0	1	1	0	1	0	1	X	X	X	1A8000h to 1AFFFFh
	SA61	0	1	1	0	1	1	0	X	X	X	1B0000h to 1B7FFFh
	SA62	0	1	1	0	1	1	1	X	X	X	1B8000h to 1BFFFFh
	SA63	0	1	1	1	0	0	0	X	X	X	1C0000h to 1C7FFFh
	SA64	0	1	1	1	0	0	1	X	X	X	1C8000h to 1CFFFFh
	SA65	0	1	1	1	0	1	0	X	X	X	1D0000h to 1D7FFFh
	SA66	0	1	1	1	0	1	1	X	X	X	1D8000h to 1DFFFFh
	SA67	0	1	1	1	1	0	0	X	X	X	1E0000h to 1E7FFFh
	SA68	0	1	1	1	1	0	1	X	X	X	1E8000h to 1EFFFFh
	SA69	0	1	1	1	1	1	0	X	X	X	1F0000h to 1F7FFFh
	SA70	0	1	1	1	1	1	1	X	X	X	1F8000h to 1FFFFFh
	GATO	U	_ '	_ '	'	_ '	<u>'</u>	'	_ ^	_ ^	^	(Continue

					S	ector /	Addres	SS				Address Range
Bank	Sector	Ban	k Add	ress								Mord Mode
		A 21	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Word Mode
	SA71	1	0	0	0	0	0	0	Х	Х	Х	200000h to 207FFFh
	SA72	1	0	0	0	0	0	1	Х	X	Х	208000h to 20FFFFh
	SA73	1	0	0	0	0	1	0	Х	X	Х	210000h to 217FFFh
	SA74	1	0	0	0	0	1	1	Х	Х	Х	218000h to 21FFFFh
	SA75	1	0	0	0	1	0	0	X	Х	Х	220000h to 227FFFh
	SA76	1	0	0	0	1	0	1	Х	Х	Х	228000h to 22FFFFh
	SA77	1	0	0	0	1	1	0	Х	X	Х	230000h to 237FFFh
	SA78	1	0	0	0	1	1	1	Х	Х	Х	238000h to 23FFFFh
	SA79	1	0	0	1	0	0	0	Х	Х	Х	240000h to 247FFFh
	SA80	1	0	0	1	0	0	1	Х	X	Х	248000h to 24FFFFh
	SA81	1	0	0	1	0	1	0	Х	Х	Х	250000h to 257FFFh
	SA82	1	0	0	1	0	1	1	Х	X	Х	258000h to 25FFFFh
	SA83	1	0	0	1	1	0	0	Х	Х	Х	260000h to 267FFFh
	SA84	1	0	0	1	1	0	1	Х	Х	Х	268000h to 26FFFFh
	SA85	1	0	0	1	1	1	0	Х	Х	Х	270000h to 277FFFh
	SA86	1	0	0	1	1	1	1	Х	Х	Х	278000h to 27FFFFh
	SA87	1	0	1	0	0	0	0	Х	Х	Х	280000h to 287FFFh
	SA88	1	0	1	0	0	0	1	Х	Х	Х	288000h to 28FFFFh
	SA89	1	0	1	0	0	1	0	Х	Х	Х	290000h to 297FFFh
	SA90	1	0	1	0	0	1	1	Х	Х	Х	298000h to 29FFFFh
	SA91	1	0	1	0	1	0	0	Х	Х	Х	2A0000h to 2A7FFFh
	SA92	1	0	1	0	1	0	1	Х	Х	Х	2A8000h to 2AFFFFh
	SA93	1	0	1	0	1	1	0	Х	Х	Х	2B0000h to 2B7FFFh
Donk C	SA94	1	0	1	0	1	1	1	Х	Х	Х	2B8000h to 2BFFFFh
Bank C	SA95	1	0	1	1	0	0	0	Х	Х	Х	2C0000h to 2C7FFFh
	SA96	1	0	1	1	0	0	1	Х	Х	Х	2C8000h to 2CFFFFh
	SA97	1	0	1	1	0	1	0	Х	Х	Х	2D0000h to 2D7FFFh
	SA98	1	0	1	1	0	1	1	Х	Х	Х	2D8000h to 2DFFFFh
	SA99	1	0	1	1	1	0	0	Х	Х	Х	2E0000h to 2E7FFFh
	SA100	1	0	1	1	1	0	1	Х	Х	Х	2E8000h to 2EFFFFh
	SA101	1	0	1	1	1	1	0	Х	Х	Х	2F0000h to 2F7FFFh
	SA102	1	0	1	1	1	1	1	Х	Х	Х	2F8000h to 2FFFFFh
	SA103	1	1	0	0	0	0	0	Х	Х	Х	300000h to 307FFFh
	SA104	1	1	0	0	0	0	1	Х	Х	Х	308000h to 30FFFFh
	SA105	1	1	0	0	0	1	0	Х	Х	Х	310000h to 317FFFh
	SA106	1	1	0	0	0	1	1	Х	Х	Х	318000h to 31FFFFh
	SA107	1	1	0	0	1	0	0	Х	Х	Х	320000h to 327FFFh
	SA108	1	1	0	0	1	0	1	Х	Х	Х	328000h to 32FFFFh
	SA109	1	1	0	0	1	1	0	X	X	X	330000h to 337FFFh
	SA110	1	1	0	0	1	1	1	X	X	X	338000h to 33FFFFh
	SA111	1	1	0	1	0	0	0	X	X	X	340000h to 347FFFh
	SA112	1	1	0	1	0	0	1	X	X	X	348000h to 34FFFFh
	SA113	1	1	0	1	0	1	0	X	X	X	350000h to 357FFFh
	SA114	1	1	0	1	0	1	1	X	X	X	358000h to 35FFFFh
	SA115	1	1	0	1	1	0	0	X	X	X	360000h to 367FFFh
	SA116	1	1	0	1	1	0	1	X	X	X	368000h to 36FFFFh
	SA117	1	1	0	1	1	1	0	X	X	X	370000h to 377FFFh
	SA117	1	1	0	1	1	1	1	X	X	X	378000h to 37FFFFh
	OATIO			ı J	<u> </u>	_ '	<u>'</u>	'		_ ^	^	(Continued

					S	ector /	Addres	SS				Address Range
Bank	Sector	Ban	k Add	ress								Mond Mode
		A 21	A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Word Mode
	SA119	1	1	1	0	0	0	0	Х	Х	Х	380000h to 387FFFh
	SA120	1	1	1	0	0	0	1	Х	Х	X	388000h to 38FFFFh
	SA121	1	1	1	0	0	1	0	Х	Х	Х	390000h to 397FFFh
	SA122	1	1	1	0	0	1	1	Х	Х	Х	398000h to 39FFFFh
	SA123	1	1	1	0	1	0	0	Х	Х	Х	3A0000h to 3A7FFFh
	SA124	1	1	1	0	1	0	1	Х	Х	X	3A8000h to 3AFFFFh
	SA125	1	1	1	0	1	1	0	Х	Х	Х	3B0000h to 3B7FFFh
	SA126	1	1	1	0	1	1	1	Х	Х	Х	3B8000h to 3BFFFFh
	SA127	1	1	1	1	0	0	0	Х	Х	X	3C0000h to 3C7FFFh
	SA128	1	1	1	1	0	0	1	Х	Х	Х	3C8000h to 3CFFFFh
	SA129	1	1	1	1	0	1	0	Х	Х	Х	3D0000h to 3D7FFFh
Bank D	SA130	1	1	1	1	0	1	1	Х	Х	Х	3D8000h to 3DFFFFh
	SA131	1	1	1	1	1	0	0	Х	Х	Х	3E0000h to 3E7FFFh
	SA132	1	1	1	1	1	0	1	Х	Х	Х	3E8000h to 3EFFFFh
	SA133	1	1	1	1	1	1	0	Х	Х	Х	3F0000h to 3F7FFFh
	SA134	1	1	1	1	1	1	1	0	0	0	3F8000h to 3F8FFFh
	SA135	1	1	1	1	1	1	1	0	0	1	3F9000h to 3F9FFFh
	SA136	1	1	1	1	1	1	1	0	1	0	3FA000h to 3FAFFFh
	SA137	1	1	1	1	1	1	1	0	1	1	3FB000h to 3FBFFFh
	SA138	1	1	1	1	1	1	1	1	0	0	3FC000h to 3FCFFFh
	SA139	1	1	1	1	1	1	1	1	0	1	3FD000h to 3FDFFFh
	SA140	1	1	1	1	1	1	1	1	1	0	3FE000h to 3FEFFFh
	SA141	1	1	1	1	1	1	1	1	1	1	3FF000h to 3FFFFFh

Sector Group Addresses Table

Sector Group	A 21	A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Sectors
SGA0	0	0	0	0	0	0	0	0	0	0	SA0
SGA1	0	0	0	0	0	0	0	0	0	1	SA1
SGA2	0	0	0	0	0	0	0	0	1	0	SA2
SGA3	0	0	0	0	0	0	0	0	1	1	SA3
SGA4	0	0	0	0	0	0	0	1	0	0	SA4
SGA5	0	0	0	0	0	0	0	1	0	1	SA5
SGA6	0	0	0	0	0	0	0	1	1	0	SA6
SGA7	0	0	0	0	0	0	0	1	1	1	SA7
						0	1				
SGA8	0	0	0	0	0	1	0	Х	Х	Х	SA8 to SA10
						1	1				
SGA9	0	0	0	0	1	Х	Х	Х	Х	Х	SA11 to SA14
SGA10	0	0	0	1	0	Х	Х	Х	Х	Х	SA15 to SA18
SGA11	0	0	0	1	1	Х	Х	Х	Х	Х	SA19 to SA22
SGA12	0	0	1	0	0	Х	Х	Х	Х	Х	SA23 to SA26
SGA13	0	0	1	0	1	Х	Х	Х	Х	Х	SA27 to SA30
SGA14	0	0	1	1	0	Х	Х	Х	Х	Х	SA31 to SA34
SGA15	0	0	1	1	1	Х	Х	Х	Х	Х	SA35 to SA38
SGA16	0	1	0	0	0	Х	Х	Х	Х	Х	SA39 to SA42
SGA17	0	1	0	0	1	X	X	X	X	X	SA43 to SA46
SGA18	0	1	0	1	0	Х	Х	Х	Х	Х	SA47 to SA50
SGA19	0	1	0	1	1	Х	Х	Х	Х	Х	SA51 to SA54
SGA20	0	1	1	0	0	X	X	X	X	X	SA55 to SA58
SGA21	0	1	1	0	1	X	X	X	X	X	SA59 to SA62
SGA22	0	1	1	1	0	X	X	X	X	X	SA63 to SA66
SGA23	0	1	1	1	1	X	X	X	X	X	SA67 to SA70
SGA24	1	0	0	0	0	X	X	X	X	X	SA71 to SA74
SGA25	1	0	0	0	1	X	X	X	X	X	SA75 to SA78
SGA26	1	0	0	1	0	X	X	X	X	X	SA79 to SA82
SGA27	1	0	0	1	1	X	X	X	X	X	SA83 to SA86
SGA28	<u>·</u> 	0	1	0	0	X	X	X	X	X	SA87 to SA90
SGA29	1	0	1	0	1	X	X	X	X	X	SA91 to SA94
SGA30	1	0	1	1	0	X	X	X	X	X	SA95 to SA98
SGA31	<u>·</u> 1	0	1	1	1	X	X	X	X	X	SA99 to SA102
SGA32	1	1	0	0	0	X	X	X	X	X	SA103 to SA106
SGA33	<u>·</u> 1	1	0	0	1	X	X	X	X	X	SA107 to SA110
SGA34	1	1	0	1	0	X	X	X	X	X	SA111 to SA114
SGA35	. 1	1	0	1	1	X	X	X	X	X	SA115 to SA118
SGA36	1	1	1	0	0	X	X	X	X	X	SA119 to SA122
SGA37	. 1	1	1	0	1	X	X	X	X	X	SA123 to SA126
SGA38	1	1	1	1	0	X	X	X	X	X	SA127 to SA130
00/100	<u>'</u>	'		'	0	0	0				0/112/ 10 0/1100
SGA39	1	1	1	1	1	0	1	X	X	X	SA131 to SA133
00/100	'	'	'	'	'	1	0	^	_ ^	^	0A131 to 0A133
SGA40	1	1	1	1	1	1	1	0	0	0	SA134
SGA40 SGA41	1	1	1	1	1	1	1	0	0	1	SA134 SA135
SGA41	1	1	1	1	1	1	1	0	1	0	SA136
SGA42 SGA43	1	1	1	1	1	1	1	0	1	1	SA136 SA137
SGA43 SGA44	1	1	1	1	1	1	1	1	0	0	SA137 SA138
SGA44 SGA45					1		1		0	1	SA136 SA139
	1	1	1	1		1		1			
SGA46	1	1	1	1	1	1	1	1	1	0	SA140
SGA47	11	1	1	1	1	1	1	1	1	1	SA141

Flash Memory Autoselect Codes Table

Туре	A21 to A12	A 6	Аз	A 2	A 1	Ao	Code (HEX)
Manufacture's Code	BA	L	L	L	L	L	04h
Device Code	BA	L	L	L	L	Н	227Eh
Extended Device	BA	L	Н	Н	Н	L	2202h
Code *2	BA	L	Н	Н	Н	Н	2201h
Sector Group Protection	Sector Group Addresses	L	L	L	Н	L	01h*1

Legend: $L = V_{IL}$, $H = V_{IH}$. See DC Characteristics for voltage levels.

^{*1 :} Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.

^{*2 :} A read cycle at address (BA) 01h outputs device code. When 227Eh was output, this indicates that there will require two additional codes, called Extended Device Codes. Therefore the system may continue reading out these Extended Device Codes at the address of (BA) 0Eh, as well as at (BA) 0Fh.

Flash Memory Command Definitions Table

Command Sequence	Bus Write Cycles	First Write (Bus Cycle	Secon Write		Third Write C	Bus ycle	Fourth Read/ Cyc	Write	Fifth Write (Bus Cycle	Sixth Write	
	Req'd	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read/Reset	1	XXXh	F0h	_	_	_	_	_	_	_	_	_	_
Read/Reset	3	555h	AAh	2AAh	55h	555h	F0h	RA*5	RD*9	_	_	_	_
Autoselect	3	555h	AAh	2AAh	55h	(BA*8) 555h	90h	_		_	_	_	_
Program	4	555h	AAh	2AAh	55h	555h	A0h	PA*6	PD*10	_	_	_	_
Program Suspend	1	BA*8	B0h	_	_	_	_	_		_	_	_	_
Program Resume	1	BA*8	30h	_	_	_	_	_	_	_	_	_	_
Chip Erase	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	555h	10h
Sector Erase	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	SA*7	30h
Erase Suspend	1	BA*8	B0h	_	_	_	_	_	_	_	_	_	_
Erase Resume	1	BA*8	30h	_	_	_	_	_	_	_	_	_	_
Extended Sector Group Protection*2	4	XXXh	60h	SPA*11	60h	SPA*11	40h	SPA*11	SD*12	_	_	_	_
Set to Fast Mode	3	555h	AAh	2AAh	55h	555h	20h	_		_	_	_	_
Fast Program*1	2	XXXh	A0h	PA*6	PD*10	_	_	_		_	_	_	_
Reset from Fast Mode*1	2	BA*8	90h	XXXh	F0h	_	_	_		_	_	_	_
Query	1	(BA*8) 55h	98h	_	_	_	_	_		_	_	_	_
HiddenROM Entry	3	555h	AAh	2AAh	55h	555h	88h	_	_	_	_	_	_
HiddenROM Program*3	4	555h	AAh	2AAh	55h	555h	A0h	(HRA*13) PA*6	PD*10	_	_	_	_
HiddenROM Exit*3	4	555h	AAh	2AAh	55h	(HRBA ^{*14}) 555h	90h	XXXh	00h	_	_	_	_

- *1 : This command is valid during Fast Mode.
- *2 : This command is valid while $\overline{RESET} = V_{ID}$.
- *3 : This command is valid during HiddenROM mode.
- *4 : The data "00h" is also acceptable.
- *5 : RA = Address of the memory location to be read
- *6 : PA = Address of the memory location to be programmed Addresses are latched on the falling edge of the write pulse.
- *7 : SA = Address of the sector to be erased. The combination of A₂₁, A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃, and A₁₂ will uniquely select any sector.
- *8 : BA = Bank Address (A₂₁, A₂₀, A₁₉)
- *9 : RD = Data read from location RA during read operation.
- *10 : PD = Data to be programmed at location PA. Data is latched on the rising edge of write pulse.
- *11: SPA = Sector group address to be protected. Set sector group address and (A₆, A₃, A₂, A₁, A₀) = (0, 0, 0, 1, 0).
- *12 : SD = Sector group protection verify data. Output 01h at protected sector group addresses and output 00h at unprotected sector group addresses.
- *13: HRA = Address of the HiddenROM area: 000000h to 00007Fh
- *14: HRBA = Bank Address of the HiddenROM area (A21 = A20 = A19 = VIL)
- Notes: Address bits A₂₁ to A₁₁ = X = "H" or "L" for all address commands except or Program Address (PA), Sector Address (SA), and Bank Address (BA), and Sector Group Address (SPA).
 - Bus operations are defined in ■DEVICE BUS OPERATION.
 - The system should generate the following address patterns: 555h or 2AAh to addresses A₁₀ to A₀
 - Both Read/Reset commands are functionally equivalent, resetting the device to the read mode.
 - The command combinations not described in this table are illegal.

2. AC Characteristics

• Read Only Operations Characteristics (Flash)

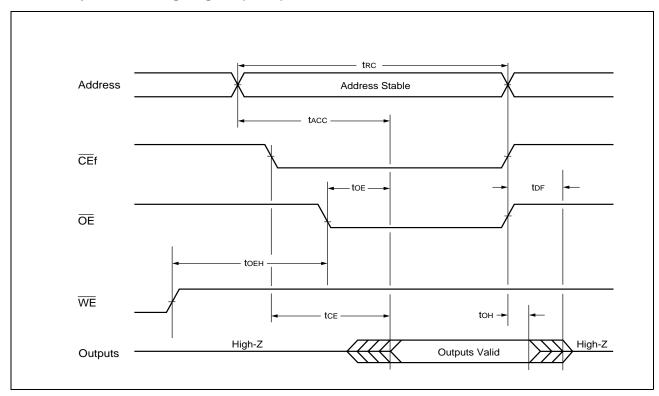
Parameter	Syn	nbol	Condition	Value	(Note)	Unit
Farameter	JEDEC	Standard	Condition	Min	Max	Offic
Read Cycle Time	t avav	t RC	_	70	_	ns
Address to Output Delay	t avqv	tacc	CEf = V _I L, OE = V _I L	_	70	ns
Chip Enable to Output Delay	t ELQV	tcef	OE = Vı∟	_	70	ns
Output Enable to Output Delay	t GLQV	t oe	_	_	30	ns
Chip Enable to Output High-Z	t ehqz	t DF	_	_	25	ns
Output Enable to Output High-Z	t GHQZ	t DF	_	_	25	ns
Output Hold Time From Addresses, CEf or OE, Whichever Occurs First	taxqx	tон	_	0	_	ns
RESET Pin Low to Read Mode	_	t READY	_	_	20	μs

Note: Test Conditions- Output Load:1 TTL gate and 30 pF

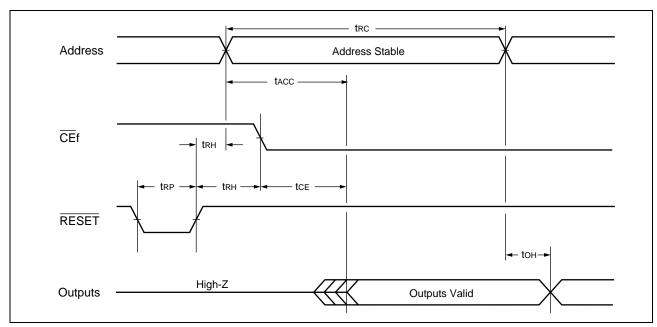
Input rise and fall times: 5 ns Input pulse levels: 0.0 V to Vccf Timing measurement reference level

Input: $0.5 \times Vccf$ Output: $0.5 \times Vccf$

• Read Operation Timing Diagram (Flash)



• Hardware Reset/Read Operation Timing Diagram (Flash)



• Write/Erase/Program Operations (Flash)

	Program Operations (Flash)	Sy	rmbol		Value		11::4
	Parameter	JEDEC	Standard	Min	Тур	Max	Unit
Write Cycle Time	Э	t avav	t wc	70	_	_	ns
Address Setup	ime	t avwl	tas	0		_	ns
Address Setup 7 Polling	ime to OE Low During Toggle Bit		taso	12	_	_	ns
Address Hold Ti	me	twlax	t AH	30		_	ns
Address Hold Ti Toggle Bit Pollin	me from CEf or OE High During g		t aht	0	_	_	ns
Data Setup Time)	t DVWH	t DS	25		_	ns
Data Hold Time		t whdx	t bн	0		_	ns
Output Enable	Read		t	0		_	ns
Hold Time	Toggle and Data Polling	_	t oeh	10		_	ns
CEf High During	Toggle Bit Polling	_	t CEPH	20		_	ns
OE High During	Toggle Bit Polling	_	t oeph	20		_	ns
Read Recover T	ime Before Write	t GHWL	t GHWL	0		_	ns
Read Recover T	ime Before Write	t GHEL	t GHEL	0		_	ns
CEf Setup Time		t ELWL	tcs	0		_	ns
WE Setup Time		twlel	tws	0		_	ns
CEf Hold Time		twheh	tсн	0		_	ns
WE Hold Time		t ehwh	twн	0		_	ns
Write Pulse Wid	th	t wLWH	twp	35		_	ns
CEf Pulse Width		teleh	t cp	35		_	ns
Write Pulse Wid	th High	t whwL	twpн	20		_	ns
CEf Pulse Width	High	t ehel	t CPH	20		_	ns
Programming O	peration	twhwh1	twhwh1		6	_	μs
Sector Erase Op	peration *1	twhwh2	t whwh2	_	0.5	_	S
Vccf Setup Time		_	tvcs	50	_	_	μs
Rise Time to Vid	*2		tvidr	500	_	_	ns
Rise Time to VAC	cc *3		tvaccr	500	_	_	ns
Voltage Transition	on Time *2	_	t vlht	4	_	_	μs
Write Pulse Wid	th *2		twpp	100	_	_	μs

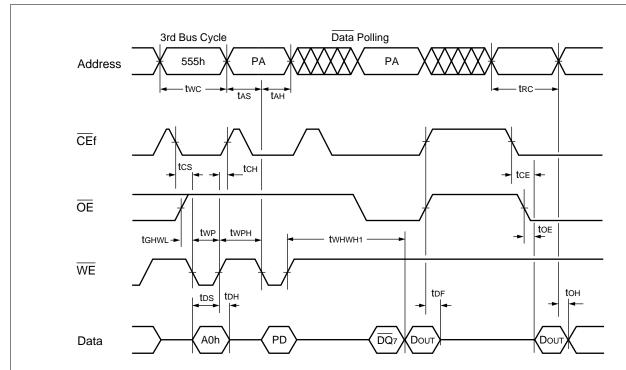
		•			
Sy	/mbol		Value		Unit
JEDEC	Standard	Min	Тур	Max	Oilit
_	toesp	4		_	μs
_	tcsp	4			μs
_	t RB	0		_	ns
_	t RP	500			ns
_	t RH	200			ns
_	t BUSY	_		90	ns
_	t eoe	_		70	ns
_	t Tow	50		_	μs
_	t spd	_	_	20	μs
		— toesp — tcsp — trb — trb — trb — trb — trh — trb — trb — tro	JEDEC Standard Min — toesp 4 — tcsp 4 — trb 0 — trb 500 — trh 200 — troe — — trow 50	JEDEC Standard Min Typ — toesp 4 — — tcsp 4 — — trb 4 — — trb 0 — — trb 500 — — trb 200 — — trow 50 —	JEDEC Standard Min Typ Max — toesp 4 — — — tcsp 4 — — — trb 0 — — — trp 500 — — — tru 200 — — — tru 200 — — — tru 50 — 70 — tru 50 — —

^{*1:} This does not include preprogramming time.

^{*2:} This timing is for Sector Group Protection operation.

^{*3:} This timing is for Accelerated Program operation.

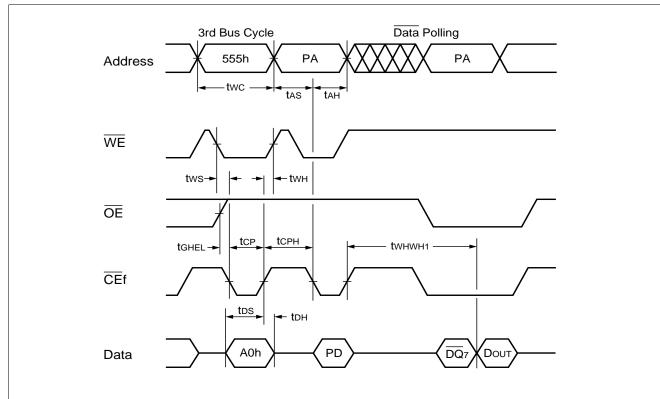
• Write Cycle (WE control) (Flash)



Notes: • PA is address of the memory location to be programmed.

- PD is data to be programmed at word address.
- DQ₇ is the output of the complement of the data written to the device.
- Dout is the output of the data written to the device.
- Figure indicates last two bus cycles out of four bus cycle sequence.

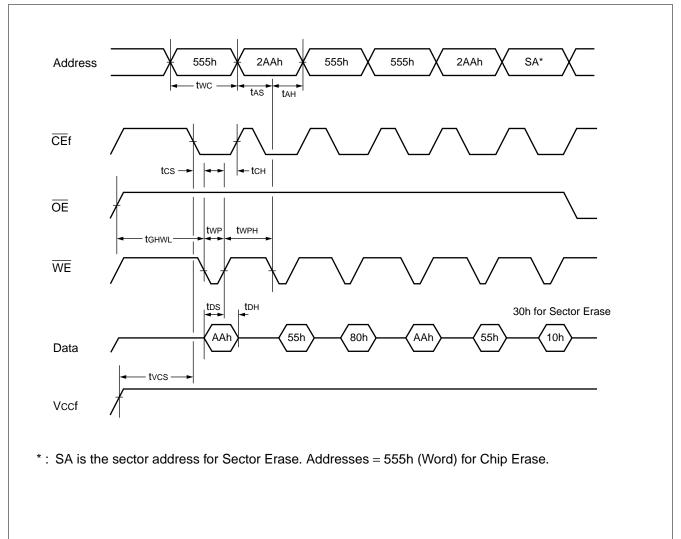
• Write Cycle (CEf control) (Flash)



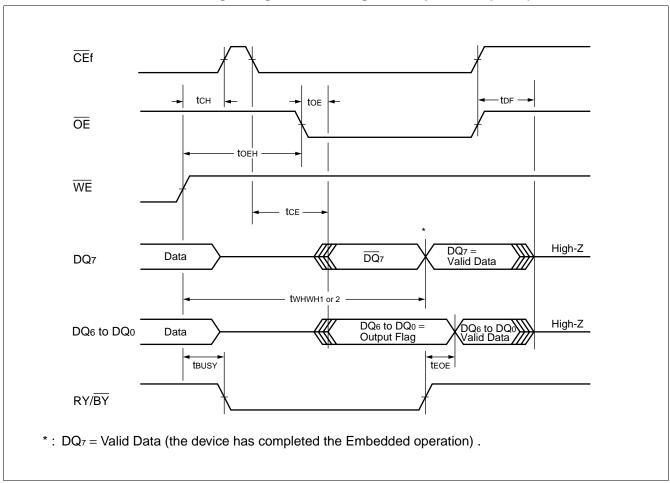
Notes: • PA is address of the memory location to be programmed.

- PD is data to be programmed at word address.
- $\overline{DQ_7}$ is the output of the complement of the data written to the device.
- Dout is the output of the data written to the device.
- Figure indicates last two bus cycles out of four bus cycle sequence.

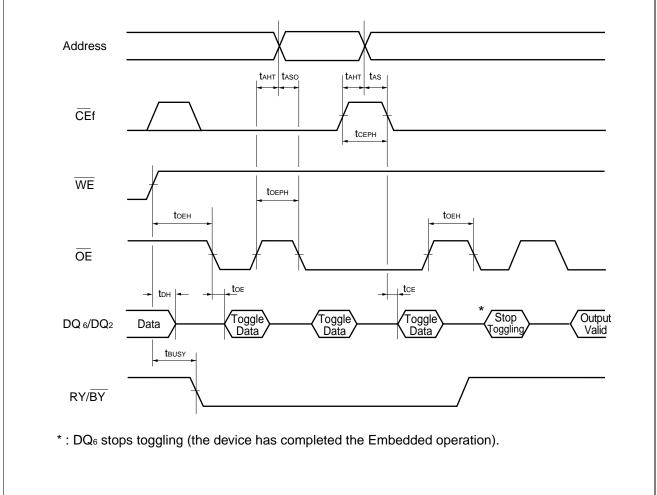
• AC Waveforms Chip/Sector Erase Operations (Flash)



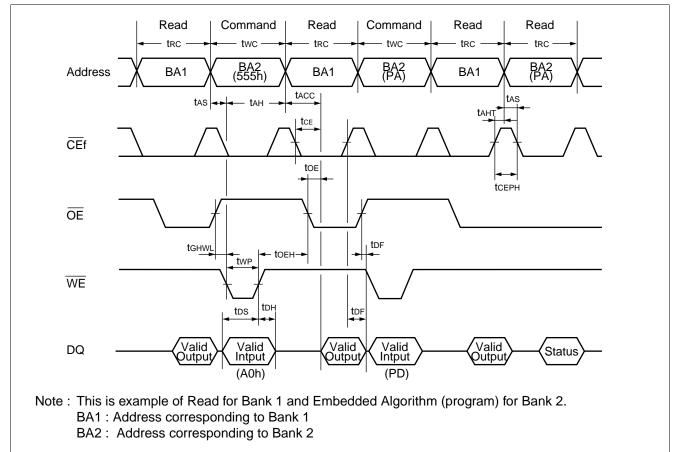
• AC Waveforms for Data Polling during Embedded Algorithm Operations (Flash)



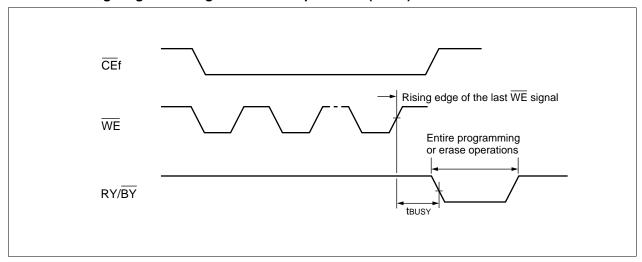




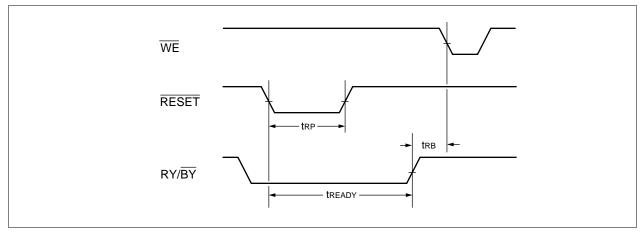
• Bank-to-bank Read/Write Timing Diagram (Flash)



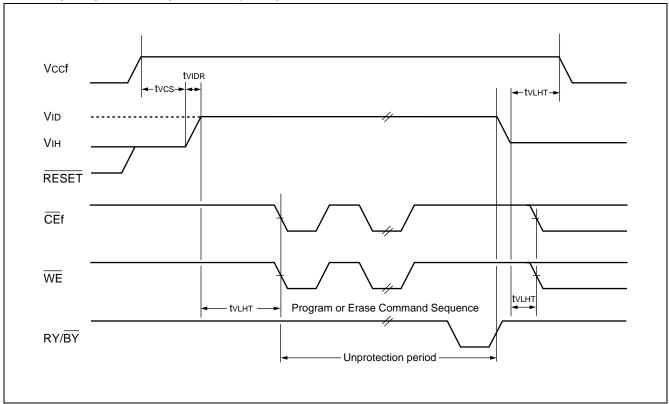
• RY/BY Timing Diagram during Write/Erase Operations (Flash)



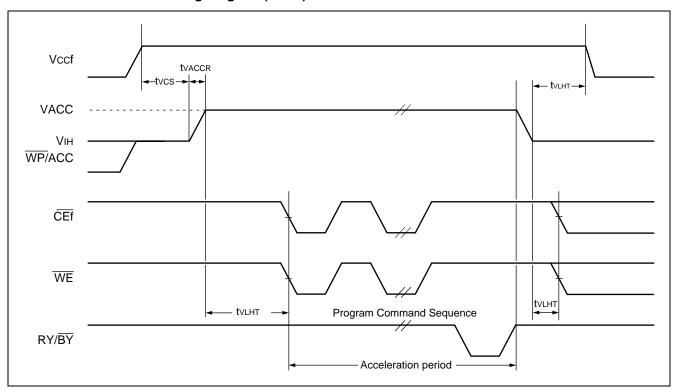
• RESET, RY/BY Timing Diagram (Flash)



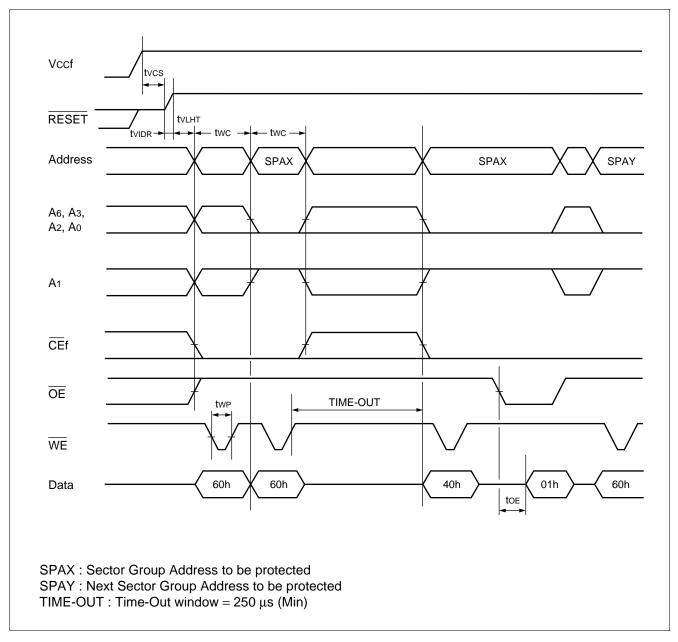
• Temporary Sector Unprotection (Flash)



• Acceleration Mode Timing Diagram (Flash)



• Extended Sector Group Protection (Flash)



3. Erase and Programming Performance (Flash)

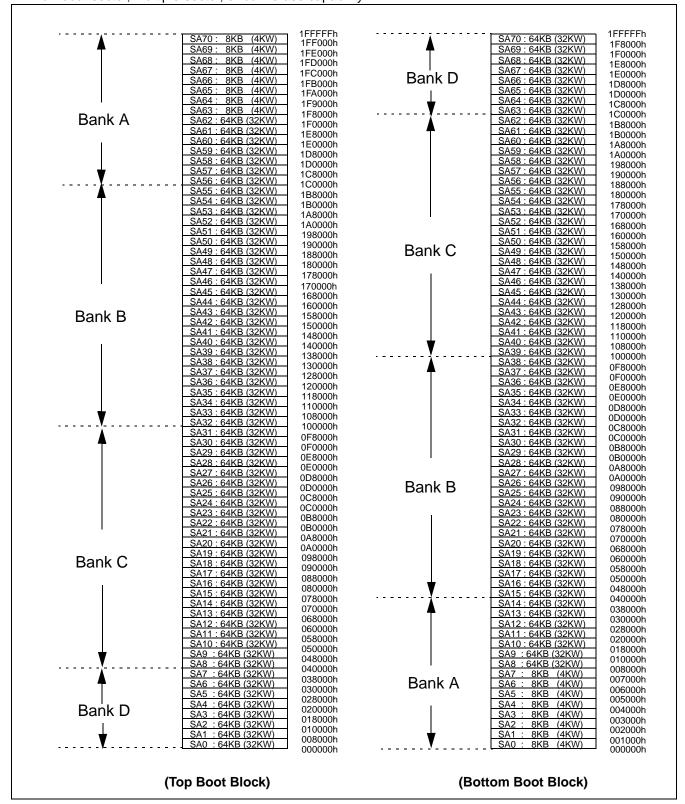
Parameter		Value		Unit	Remarks			
Parameter	Min	Тур	Max	Offic	Remarks			
Sector Erase Time	_	0.5	2.0	S	Excludes programming time prior to erasure			
Word Programming Time	_	6	100	μs	Excludes system-level overhead			
Chip Programming Time	_	_	200	S	Excludes system-level overhead			
Erase/Program Cycle	100,000	_	_	cycle				

Typical Erase conditions $T_A = +25^{\circ}C$, VCCf_1 & VCCf_2 = 2.9 V Typical Program conditions $T_A = +25^{\circ}C$, VCCf_1 & VCCf_2 = 2.9 V

Data= Checker

■ 32M FLASH MEMORY CHARACTERISTICS for MCP

- Flexible Sector-erase Architecture on Flash Memory
- Eight 4 K words, and sixty three 32 K words.
- · Individual-sector, multiple-sector, or bulk-erase capability.



FlexBank™ Architecture Table

Bank		Bank 1		Bank 2
Splits	Volume	Combination	Volume	Combination
1	4 Mbit	Bank A	28 Mbit	Bank B, C, D
2	12 Mbit	Bank B	20 Mbit	Bank A, C, D
3	12 Mbit	Bank C	20 Mbit	Bank A, B, D
4	4 Mbit	Bank D	28 Mbit	Bank A, B, C

Example of Virtual Banks Combination Table

Bank		Ba	nk 1		Ва	nnk 2
Splits	Volume	Combination	Sector Size	Volume	Combination	Sector Size
					Bank B	
			8×8 Kbyte/4 Kword		+	
1	4 Mbit	Bank A	+	28 Mbit	Bank C	56 × 64 Kbyte/32 Kword
			7 × 64 Kbyte/32 Kword		+	
					Bank D	
		Bank A	8 × 8 Kbyte/4 Kword		Bank B	
2	8 Mbit	+	+	24 Mbit	+	48 × 64 Kbyte/32 Kword
		Bank D	15 × 64 Kbyte/32 Kword		Bank C	
		Bank A	8 × 8 Kbyte/4 Kword		Bank C	
3	16 Mbit	+	+	16 Mbit	+	32 × 64 Kbyte/32 Kword
		Bank B	31×64 Kbyte/32 Kword		Bank D	

Note: When multiple sector erase over several banks is operated, the system cannot read out of the bank to which a sector being erased belongs. For example, suppose that erasing is taking place at both Bank A and Bank B, neither Bank A nor Bank B is read out (they would output the sequence flag once they were selected.)

Meanwhile the system would get to read from either Bank C or Bank D.

Sector Address Table (Top Boot Type)

В					Se	ctor	addre	SS							
a n	Sector		Bank ddres									Sector size (Kwords)	Address range		
k		A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11				
	SA0	0	0	0	0	0	0	Χ	Χ	Χ	Χ	32	000000h to 007FFFh		
	SA1	0	0	0	0	0	1	Х	Χ	Χ	Х	32	008000h to 00FFFFh		
В	SA2	0	0	0	0	1	0	Х	Χ	Χ	Χ	32	010000h to 017FFFh		
a n	SA3	0	0	0	0	1	1	Χ	Χ	Χ	Χ	32	018000h to 01FFFFh		
l ''	SA4	0	0	0	1	0	0	Х	Χ	Х	Х	32	020000h to 027FFFh		
D	SA5	0	0	0	1	0	1	Χ	Χ	Χ	Χ	32	028000h to 02FFFFh		
	SA6	0	0	0	1	1	0	Χ	Χ	Χ	Χ	32	030000h to 037FFFh		
	SA7	0	0	0	1	1	1	Х	Χ	Χ	Χ	32	038000h to 03FFFFh		
	SA8	0	0	1	0	0	0	Χ	Χ	Χ	Χ	32	040000h to 047FFFh		
	SA9	0	0	1	0	0	1	Χ	Χ	Χ	Χ	32	048000h to 04FFFFh		
	SA10	0	0	1	0	1	0	Χ	Χ	Χ	Χ	32	050000h to 057FFFh		
	SA11	0	0	1	0	1	1	Χ	Χ	Χ	Χ	32	058000h to 05FFFFh		
	SA12	0	0	1	1	0	0	Χ	Χ	Χ	Χ	32	060000h to 067FFFh		
	SA13	0	0	1	1	0	1	Χ	Χ	Χ	Χ	32	068000h to 06FFFFh		
	SA14	0	0	1	1	1	0	Х	Χ	Х	Х	32	070000h to 077FFFh		
	SA15	0	0	1	1	1	1	Χ	Χ	Χ	Χ	32	078000h to 07FFFFh		
	SA16	0	1	0	0	0	0	Х	Χ	Χ	Χ	32	080000h to 087FFFh		
	SA17	0	1	0	0	0	1	Х	Χ	Х	Х	32	088000h to 08FFFFh		
В	SA18	0	1	0	0	1	0	Χ	Χ	Χ	Χ	32	090000h to 097FFFh		
a	SA19	0	1	0	0	1	1	Χ	Χ	Χ	Χ	32	098000h to 09FFFFh		
n k	SA20	0	1	0	1	0	0	Х	Χ	Χ	Х	32	0A0000h to 0A7FFFh		
Ĉ	SA21	0	1	0	1	0	1	Χ	Χ	Χ	Χ	32	0A8000h to 0AFFFFh		
	SA22	0	1	0	1	1	0	Х	Χ	Χ	Χ	32	0B0000h to 0B7FFFh		
	SA23	0	1	0	1	1	1	Х	Χ	Χ	Х	32	0B8000h to 0BFFFFh		
	SA24	0	1	1	0	0	0	Х	Χ	Χ	Χ	32	0C0000h to 0C7FFFh		
	SA25	0	1	1	0	0	1	Χ	Χ	Χ	Χ	32	0C8000h to 0CFFFFh		
	SA26	0	1	1	0	1	0	Χ	Χ	Χ	Χ	32	0D0000h to 0D7FFFh		
	SA27	0	1	1	0	1	1	Х	Χ	Χ	Х	32	0D8000h to 0DFFFFh		
	SA28	0	1	1	1	0	0	Х	Χ	Χ	Х	32	0E0000h to 0E7FFFh		
	SA29	0	1	1	1	0	1	Х	Х	Χ	Х	32	0E8000h to 0EFFFFh		
	SA30	0	1	1	1	1	0	Х	Χ	Χ	Х	32	0F0000h to 0F7FFFh		
	SA31	0	1	1	1	1	1	Χ	Χ	Χ	Χ	32	0F8000h to 0FFFFh		

	ontinued)	Sector address													
B a n	Sector					COL	addic	33					Address range		
k		A ₂₀	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11	(*************************			
	SA32	1	0	0	0	0	0	Х	Х	Х	Х	32	100000h to 107FFFh		
	SA33	1	0	0	0	0	1	Х	Х	Х	Х	32	108000h to 10FFFFh		
	SA34	1	0	0	0	1	0	Х	Х	Х	Х	32	110000h to 117FFFh		
	SA35	1	0	0	0	1	1	Х	Х	Х	Х	32	118000h to 11FFFFh		
	SA36	1	0	0	1	0	0	Х	Х	Х	Х	32	120000h to 127FFFh		
	SA37	1	0	0	1	0	1	Х	Х	Х	Х	32	128000h to 12FFFFh		
	SA38	1	0	0	1	1	0	Х	Х	Х	Х	32	130000h to 137FFFh		
	SA39	1	0	0	1	1	1	Х	Х	Х	Х	32	138000h to 13FFFFh		
	SA40	1	0	1	0	0	0	Х	Х	Х	Х	32	140000h to 147FFFh		
	SA41	1	0	1	0	0	1	Х	Х	Х	Х	32	148000h to 14FFFFh		
В	SA42	1	0	1	0	1	0	Х	Х	Х	Х	32	150000h to 157FFFh		
а	SA43	1	0	1	0	1	1	Х	Х	Х	Х	32	158000h to 15FFFFh		
n k	SA44	1	0	1	1	0	0	Х	Х	Х	Х	32	160000h to 167FFFh		
В	SA45	1	0	1	1	0	1	Х	Х	Х	Х	32	168000h to 16FFFFh		
	SA46	1	0	1	1	1	0	Х	Х	Х	Х	32	170000h to 177FFFh		
	SA47	1	0	1	1	1	1	Х	Х	Х	Х	32	178000h to 17FFFFh		
	SA48	1	1	0	0	0	0	Х	Х	Х	Х	32	180000h to 187FFFh		
	SA49	1	1	0	0	0	1	Х	Х	Х	Х	32	188000h to 18FFFFh		
	SA50	1	1	0	0	1	0	Х	Х	Х	Х	32	190000h to 197FFFh		
	SA51	1	1	0	0	1	1	Х	Х	Х	Х	32	198000h to 19FFFFh		
	SA52	1	1	0	1	0	0	Х	Х	Х	Х	32	1A0000h to 1A7FFFh		
	SA53	1	1	0	1	0	1	Χ	Х	Χ	Х	32	1A8000h to 1AFFFFh		
	SA54	1	1	0	1	1	0	Х	Х	Х	Х	32	1B0000h to 1B7FFFh		
	SA55	1	1	0	1	1	1	Х	Х	Х	Х	32	1B8000h to 1BFFFFh		
	SA56	1	1	1	0	0	0	Χ	Х	Χ	Х	32	1C0000h to 1C7FFFh		
	SA57	1	1	1	0	0	1	Х	Х	Х	Х	32	1C8000h to 1CFFFFh		
	SA58	1	1	1	0	1	0	Х	Х	Х	Х	32	1D0000h to 1D7FFFh		
	SA59	1	1	1	0	1	1	Х	Х	Х	Х	32	1D8000h to 1DFFFFh		
	SA60	1	1	1	1	0	0	Χ	Χ	Х	Х	32	1E0000h to 1E7FFFh		
В	SA61	1	1	1	1	0	1	Х	Х	Х	Х	32	1E8000h to 1EFFFFh		
a	SA62	1	1	1	1	1	0	Χ	Χ	Х	Х	32	1F0000h to 1F7FFFh		
n	SA63	1	1	1	1	1	1	0	0	0	Х	4	1F8000h to 1F8FFFh		
k	SA64	1	1	1	1	1	1	0	0	1	Х	4	1F9000h to 1F9FFFh		
Α	SA65	1	1	1	1	1	1	0	1	0	Х	4	1FA000h to 1FAFFFh		
	SA66	1	1	1	1	1	1	0	1	1	Х	4	1FB000h to 1FBFFFh		
	SA67	1	1	1	1	1	1	1	0	0	Х	4	1FC000h to 1FCFFFh		
	SA68	1	1	1	1	1	1	1	0	1	Х	4	1FD000h to 1FDFFFh		
	SA69	1	1	1	1	1	1	1	1	0	Х	4	1FE000h to 1FEFFFh		
	SA70		1	1	1	1	1	1	1	1	Х	4	1FF000h to 1FFFFFh		

Sector Address Table (Bottom Boot Type)

В					Se	ctor a	addre	SS						
a n	Sector		Bank ddres									Sector size (Kwords)	Address range	
k		A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11			
	SA70	1	1	1	1	1	1	Χ	Χ	Χ	Χ	32	1F8000h to 1FFFFFh	
	SA69	1	1	1	1	1	0	Х	Χ	Χ	Χ	32	1F0000h to 1F7FFFh	
В	SA68	1	1	1	1	0	1	Х	Χ	Χ	Χ	32	1E8000h to 1EFFFFh	
a	SA67	1	1	1	1	0	0	Χ	Χ	Χ	Χ	32	1E0000h to 1E7FFFh	
n k	SA66	1	1	1	0	1	1	Х	Χ	Χ	Χ	32	1D8000h to 1DFFFFh	
D	SA65	1	1	1	0	1	0	Х	Χ	Χ	Χ	32	1D0000h to 1D7FFFh	
	SA64	1	1	1	0	0	1	Χ	Χ	Χ	Χ	32	1C8000h to 1CFFFFh	
	SA63	1	1	1	0	0	0	Х	Χ	Χ	Χ	32	1C0000h to 1C7FFFh	
	SA62	1	1	0	1	1	1	Χ	Χ	Χ	Χ	32	1B8000h to 1BFFFFh	
	SA61	1	1	0	1	1	0	Χ	Χ	Χ	Χ	32	1B0000h to 1B7FFFh	
	SA60	1	1	0	1	0	1	Χ	Χ	Χ	Χ	32	1A8000h to 1AFFFFh	
	SA59	1	1	0	1	0	0	Χ	Χ	Χ	Χ	32	1A0000h to 1A7FFFh	
	SA58	1	1	0	0	1	1	Χ	Χ	Χ	Χ	32	198000h to 19FFFFh	
	SA57	1	1	0	0	1	0	Χ	Χ	Χ	Χ	32	190000h to 197FFFh	
	SA56	1	1	0	0	0	1	Χ	Χ	Χ	Χ	32	188000h to 18FFFFh	
	SA55	1	1	0	0	0	0	Χ	Χ	Χ	Χ	32	180000h to 187FFFh	
	SA54	1	0	1	1	1	1	Χ	Χ	Χ	Χ	32	178000h to 17FFFFh	
	SA53	1	0	1	1	1	0	Χ	Χ	Χ	Χ	32	170000h to 177FFFh	
В	SA52	1	0	1	1	0	1	Χ	Χ	Χ	Χ	32	168000h to 16FFFFh	
a n	SA51	1	0	1	1	0	0	Х	Χ	Χ	Χ	32	160000h to 167FFFh	
k	SA50	1	0	1	0	1	1	Χ	Χ	Χ	Χ	32	158000h to 15FFFFh	
C	SA49	1	0	1	0	1	0	Χ	Χ	Χ	Χ	32	150000h to 157FFFh	
	SA48	1	0	1	0	0	1	Х	Χ	Χ	Χ	32	148000h to 14FFFFh	
	SA47	1	0	1	0	0	0	Χ	Χ	Χ	Χ	32	140000h to 147FFFh	
	SA46	1	0	0	1	1	1	Χ	Χ	Χ	Χ	32	138000h to 13FFFFh	
	SA45	1	0	0	1	1	0	Χ	Χ	Χ	Χ	32	130000h to 137FFFh	
	SA44	1	0	0	1	0	1	Χ	Χ	Χ	Χ	32	128000h to 12FFFFh	
	SA43	1	0	0	1	0	0	Χ	Χ	Χ	Х	32	120000h to 127FFFh	
	SA42	1	0	0	0	1	1	Χ	Χ	Х	Х	32	118000h to 11FFFFh	
	SA41	1	0	0	0	1	0	Χ	Χ	Х	Х	32	110000h to 117FFFh	
	SA40	1	0	0	0	0	1	Χ	Χ	Χ	Х	32	108000h to 10FFFFh	
	SA39	1	0	0	0	0	0	Χ	Χ	Χ	Χ	32	100000h to 107FFFh	

В					Se	ctor	addre	ss						
a n	Sector		Bank ddres									Sector size (Kwords)	Address range	
k		A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	A 11			
	SA38	0	1	1	1	1	1	Х	Χ	Χ	Х	32	0F8000h to 0FFFFFh	
	SA37	0	1	1	1	1	0	Χ	Χ	Χ	Х	32	0F0000h to 0F7FFFh	
	SA36	0	1	1	1	0	1	Χ	Χ	Х	Х	32	0E8000h to 0EFFFFh	
	SA35	0	1	1	1	0	0	Χ	Χ	Χ	Χ	32	0E0000h to 0E7FFFh	
	SA34	0	1	1	0	1	1	Χ	Χ	Х	Х	32	0D8000h to 0DFFFFh	
	SA33	0	1	1	0	1	0	Χ	Χ	Χ	Χ	32	0D0000h to 0D7FFFh	
	SA32	0	1	1	0	0	1	Х	Χ	Χ	Х	32	0C8000h to 0CFFFFh	
	SA31	0	1	1	0	0	0	Χ	Χ	Χ	Х	32	0C0000h to 0C7FFFh	
	SA30	0	1	0	1	1	1	Х	Χ	Χ	Х	32	0B8000h to 0BFFFFh	
	SA29	0	1	0	1	1	0	Х	Χ	Χ	Х	32	0B0000h to 0B7FFFh	
В	SA28	0	1	0	1	0	1	Х	Χ	Х	Х	32	0A8000h to 0AFFFFh	
a n	SA27	0	1	0	1	0	0	Х	Χ	Χ	Х	32	0A0000h to 0A7FFFh	
k	SA26	0	1	0	0	1	1	Х	Χ	Х	Х	32	098000h to 09FFFFh	
В	SA25	0	1	0	0	1	0	Х	Χ	Χ	Х	32	090000h to 097FFFh	
	SA24	0	1	0	0	0	1	Х	Χ	Х	Х	32	088000h to 08FFFFh	
	SA23	0	1	0	0	0	0	Х	Χ	Х	Х	32	080000h to 087FFFh	
	SA22	0	0	1	1	1	1	Х	Χ	Χ	Х	32	078000h to 07FFFFh	
	SA21	0	0	1	1	1	0	Х	Χ	Х	Х	32	070000h to 077FFFh	
	SA20	0	0	1	1	0	1	Х	Χ	Х	Х	32	068000h to 06FFFFh	
	SA19	0	0	1	1	0	0	Х	Χ	Χ	Х	32	060000h to 067FFFh	
	SA18	0	0	1	0	1	1	Х	Χ	Х	Х	32	058000h to 05FFFFh	
	SA17	0	0	1	0	1	0	Х	Χ	Х	Х	32	050000h to 057FFFh	
	SA16	0	0	1	0	0	1	Х	Χ	Χ	Х	32	048000h to 04FFFFh	
	SA15	0	0	1	0	0	0	Х	Χ	Х	Х	32	040000h to 047FFFh	
	SA14	0	0	0	1	1	1	Х	Χ	Χ	Х	32	038000h to 03FFFFh	
	SA13	0	0	0	1	1	0	Х	Χ	Χ	Х	32	030000h to 037FFFh	
	SA12	0	0	0	1	0	1	Х	Χ	Х	Х	32	028000h to 02FFFFh	
	SA11	0	0	0	1	0	0	Х	Χ	Х	Х	32	020000h to 027FFFh	
	SA10	0	0	0	0	1	1	Х	Χ	Χ	Х	32	018000h to 01FFFFh	
В	SA9	0	0	0	0	1	0	Х	Χ	Х	Х	32	010000h to 017FFFh	
а	SA8	0	0	0	0	0	1	Х	Χ	Х	Х	32	008000h to 00FFFFh	
n	SA7	0	0	0	0	0	0	1	1	1	Х	4	007000h to 007FFFh	
k	SA6	0	0	0	0	0	0	1	1	0	Х	4	006000h to 006FFFh	
Α	SA5	0	0	0	0	0	0	1	0	1	Х	4	005000h to 005FFFh	
	SA4	0	0	0	0	0	0	1	0	0	Х	4	004000h to 004FFFh	
	SA3	0	0	0	0	0	0	0	1	1	Х	4	003000h to 003FFFh	
	SA2	0	0	0	0	0	0	0	1	0	Х	4	002000h to 002FFFh	
	SA1	0	0	0	0	0	0	0	0	1	Х	4	001000h to 001FFFh	
	SA0	0	0	0	0	0	0	0	0	0	Х	4	000000h to 000FFFh	

Sector Group Address Table (Top Boot Type)

Sector group	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Sectors
SGA0	0	0	0	0	0	0	Х	Х	Х	SA0
					0	1				
SGA1	0	0	0	0	1	0	Х	X	Х	SA1 to SA3
					1	1				
SGA2	0	0	0	1	Х	Х	Х	Х	Х	SA4 to SA7
SGA3	0	0	1	0	Х	Х	Х	Х	Х	SA8 to SA11
SGA4	0	0	1	1	Χ	Х	Х	Х	Х	SA12 to SA15
SGA5	0	1	0	0	Χ	Х	Х	Х	Х	SA16 to SA19
SGA6	0	1	0	1	Х	Х	Х	Х	Х	SA20 to SA23
SGA7	0	1	1	0	Χ	Х	Х	Х	Х	SA24 to SA27
SGA8	0	1	1	1	Χ	Х	Х	Х	Х	SA28 to SA31
SGA9	1	0	0	0	Х	Х	Х	Х	Х	SA32 to SA35
SGA10	1	0	0	1	Χ	Х	Х	Х	Х	SA36 to SA39
SGA11	1	0	1	0	Χ	Х	Х	Х	Х	SA40 to SA43
SGA12	1	0	1	1	Χ	Х	Х	Х	Х	SA44 to SA47
SGA13	1	1	0	0	Χ	Х	Х	Х	Х	SA48 to SA51
SGA14	1	1	0	1	Χ	Х	Х	Х	Х	SA52 to SA55
SGA15	1	1	1	0	Χ	Х	Х	Х	Х	SA56 to SA59
					0	0				
SGA16	1	1	1	1	0	1	Х	X	Х	SA60 to SA62
					1	0				
SGA17	1	1	1	1	1	1	0	0	0	SA63
SGA18	1	1	1	1	1	1	0	0	1	SA64
SGA19	1	1	1	1	1	1	0	1	0	SA65
SGA20	1	1	1	1	1	1	0	1	1	SA66
SGA21	1	1	1	1	1	1	1	0	0	SA67
SGA22	1	1	1	1	1	1	1	0	1	SA68
SGA23	1	1	1	1	1	1	1	1	0	SA69
SGA24	1	1	1	1	1	1	1	1	1	SA70

Sector Group Address Table (Bottom Boot Type)

Sector group	A 20	A 19	A 18	A 17	A 16	A 15	A 14	A 13	A 12	Sectors	
SGA0	0	0	0	0	0	0	0	0	0	SA0	
SGA1	0	0	0	0	0	0	0	0	1	SA1	
SGA2	0	0	0	0	0	0	0	1	0	SA2	
SGA3	0	0	0	0	0	0	0	1	1	SA3	
SGA4	0	0	0	0	0	0	1	0	0	SA4	
SGA5	0	0	0	0	0	0	1	0	1	SA5	
SGA6	0	0	0	0	0	0	1	1	0	SA6	
SGA7	0	0	0	0	0	0	1	1	1	SA7	
					0	1					
SGA8	0	0	0	0	1	0	Х	Х	X	SA8 to SA10	
					1	1					
SGA9	0	0	0	1	Х	Х	Х	Х	Х	SA11 to SA14	
SGA10	0	0	1	0	Х	Х	Х	Х	Х	SA15 to SA18	
SGA11	0	0	1	1	Х	Χ	Х	Х	Х	SA19 to SA22	
SGA12	0	1	0	0	Х	Х	Х	Х	Х	SA23 to SA26	
SGA13	0	1	0	1	Х	Х	Х	Х	Х	SA27 to SA30	
SGA14	0	1	1	0	Х	Х	Х	Х	Х	SA31 to SA34	
SGA15	0	1	1	1	Х	Х	Х	Х	Х	SA35 to SA38	
SGA16	1	0	0	0	Х	Х	Х	Х	Х	SA39 to SA42	
SGA17	1	0	0	1	Х	Х	Х	Х	Х	SA43 to SA46	
SGA18	1	0	1	0	Х	Х	Х	Х	Х	SA47 to SA50	
SGA19	1	0	1	1	Х	Х	Х	Х	Х	SA51 to SA54	
SGA20	1	1	0	0	Х	Χ	Х	Х	Х	SA55 to SA58	
SGA21	1	1	0	1	Х	Х	Х	Х	Х	SA59 to SA62	
SGA22	1	1	1	0	Х	Х	Х	Х	Х	SA63 to SA66	
					0	0					
SGA23	1	1	1	1	0	1	Х	Х	X	SA67 to SA69	
					1	0	1				
SGA24	1	1	1	1	1	1	Х	Х	Х	SA70	

Sector Group Protection Verify Autoselect Codes Table (Top Boot Type)

Туре	A ₂₀ to A ₁₂	A 6	A 3	A 2	A 1	Ao	Code (HEX)
Manufacture's Code	BA	VIL	Vıl	Vıl	VIL	VIL	04h
Device Code	BA	VIL	Vıl	Vıl	VIL	ViH	227Eh
Extended Device	BA	VIL	Vih	ViH	ViH	Vıl	220Ah
Code	BA	VIL	Vih	ViH	ViH	ViH	2201h
Sector Group Protection	SA	VıL	VıL	VIL	ViH	VıL	01h*

^{*:} Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.

Expanded Autoselect Code Table (Top Boot Type)

Туре	Code	DQ ₁₅	DQ ₁₄	DQ ₁₃	DQ ₁₂	DQ ₁₁	DQ ₁₀	DQ ₉	DQ₃	DQ ₇	DQ ₆	DQ ₅	DQ ₄	DQ₃	DQ ₂	DQ ₁	DQ₀
Manufacture's Code	04h	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device Code	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
Extended	220Ah	0	0	1	0	0	0	1	0	0	0	0	0	1	0	1	0
Device Code	2201h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	1
Sector Group Protection	01h	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

Sector Group Protection Verify Autoselect Codes Table (Bottom Boot Type)

Туре	A20 to A12	A 6	A 3	A ₂	A 1	Ao	Code (HEX)
Manufacture's Code	BA	VIL	VIL	VIL	VIL	VIL	04h
Device Code	BA	VIL	VIL	VIL	VIL	ViH	227Eh
Extended Device Code	BA	VIL	ViH	ViH	ViH	VIL	220Ah
Exterided Device Code	BA	VIL	ViH	ViH	ViH	ViH	2200h
Sector Group Protection	SA	Vıl	Vıl	VıL	ViH	VıL	01h*

^{*:} Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.

Expanded Autoselect Code Table (Bottom Boot Type)

Туре	Code	DQ ₁₅	DQ ₁₄	DQ ₁₃	DQ ₁₂	DQ ₁₁	DQ ₁₀	DQ ₉	DQ8	DQ ₇	DQ ₆	DQ ₅	DQ ₄	DQ₃	DQ ₂	DQ ₁	DQ₀
Manufacture's Code	04h	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device Code	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
Extended	220Ah	0	0	1	0	0	0	1	0	0	0	0	0	1	0	1	0
Device Code	2200h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	0
Sector Group Protection	01h	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

Command Definitions Table

Command sequence	Bus write cycles	First write			ond bus te cycle Third bus write cycle				Fifth write		Sixth write		
1	req'd	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read/Reset*1	1	XXXh	F0h	_	_	_	_	_	_	_	_	_	—
Read/Reset*1	3	555h	AAh	2AAh	55h	555h	F0h	RA*7	RD*11	_	_	_	_
Autoselect	3	555h	AAh	2AAh	55h	(BA* ¹⁰) 555h	90h	_	_	_	_	_	_
Program	4	555h	AAh	2AAh	55h	555h	A0h	PA*8	PD*12	_	_	_	_
Program Suspend	1	BA*10	B0h	_		_	_		_	_		_	_
Program Resume	1	BA*10	30h	_		_	_		_	_		_	_
Chip Erase	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	555h	10h
Sector Erase	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	SA*9	30h
Erase Suspend	1	BA*10	B0h	_	_	_	_		_	_	_	_	_
Erase Resume	1	BA*10	30h	_	_	_	_	_	_	_	_	_	_
Set to Fast Mode	3	555h	AAh	2AAh	55h	555h	20h	_	_	_	_	_	_
Fast Program *2	2	XXXh	A0h	PA*8	PD*12	_	_	_	_	_	_	_	_
Reset from Fast Mode *2	2	BA*10	90h	XXXh	F0h*6	_	_	_	_	_	_	_	_
Extended Sector Group Protection *3	4	XXXh	60h	SPA*13	60h	SPA*13	40h	SPA*13	SD*14	_	_	_	_
Query *4	1	(BA* ¹⁰) 55h	98h	_	_	_	_	_	_	_	_	_	_
HiddenROM Entry	3	555h	AAh	2AAh	55h	555h	88h	_	_	_	_	_	_
HiddenROM Program *5	4	555h	AAh	2AAh	55h	555h	A0h	(HRA*15) PA*8	PD*12	_	_	_	_
HiddenROM Exit *5	4	555h	AAh	2AAh	55h	(HRBA* ¹⁶) 555h	90h	XXXh	00h	_	_	_	_

(Continued)

- *1 : Both of these reset commands are equivalent.
- *2 : This command is valid during Fast Mode.
- *3 : This command is valid while $\overline{RESET} = V_{ID}$.
- *4: The valid address are A6 to A0.
- *5: This command is valid during HiddenROM mode.
- *6: The date "00h" is also acceptable.
- *7: RA = Address of the memory location to be read
- *8: PA = Address of the memory location to be programmed Addresses are latched on the falling edge of the write pulse.
- *9: SA = Address of the sector to be erased. The combination of A₂₀, A₁₉, A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃, and A₁₂ will uniquely select any sector.
- *10:BA = Bank Address (A20 to A18)
- *11:RD = Data read from location RA during read operation.
- *12:PD = Data to be programmed at location PA. Data is latched on the rising edge of write pulse.
- *13:SPA = Sector group address to be protected. Set sector group address and $(A_6, A_3, A_2, A_1, A_0) = (0, 0, 0, 1, 0)$.
- *14:SD = Sector group protection verify data. Output 01h at protected sector group addresses and output 00h at unprotected sector group addresses.
- *15:HRA = Address of the HiddenROM area

Top Boot Type Word Mode: 1FFF80h to 1FFFFFh Bottom Boot Type Word Mode: 000000h to 00007Fh

*16:HRBA = Bank Address of the HiddenROM area

Top Boot Type : $A_{20} = A_{19} = A_{18} = 1$ Bottom Boot Type : $A_{20} = A_{19} = A_{18} = 0$

- Notes: Address bits A₂₀ to A₁₁ = X = "H" or "L" for all address commands except or Program Address (PA), Sector Address (SA), Bank Address (BA).
 - Bus operations are defined in
 - "User Bus Operations Tables (BYTE = VIH)" (■DEVICE BUS OPERATION).
 - The system should generate the following address patterns :

Word Mode: 555h or 2AAh to addresses A10 to A0

- Both Read/Reset commands are functionally equivalent, resetting the device to the read mode.
- Command combinations not described in "Command Definitions Table" are illegal.

2. AC Characteristics

• Read Only Operations Characteristics

Parameter	Sym	bols	Condition	Value*		Unit
raiametei	JEDEC	Standard	Condition	Min	Max	Unit
Read Cycle Time	tavav	t RC	_	70	_	ns
Address to Output Delay	tavqv	tacc	<u>CE</u> f = V _{IL} , <u>OE</u> = V _{IL}		70	ns
Chip Enable to Output Delay	t ELQV	t ce	OE = VIL		70	ns
Output Enable to Output Delay	t GLQV	toe	_		30	ns
Chip Enable to Output High-Z	t EHQZ	t DF	_		25	ns
Output Enable to Output High-Z	t GHQZ	t DF	_		25	ns
Output Hold Time from Addresses, CEf or OE, Whichever Occurs First	taxqx	tон	_	0	_	ns
RESET Pin Low to Read Mode	_	t READY	_		20	μs

*: Test Conditions — Output Load : 1 TTL gate and 30 pF

Input rise and fall times: 5 ns

Input pulse levels : 0.0 V to 3.0 V Timing measurement reference level

Input: 0.5 × Vccf Output: 0.5 × Vccf

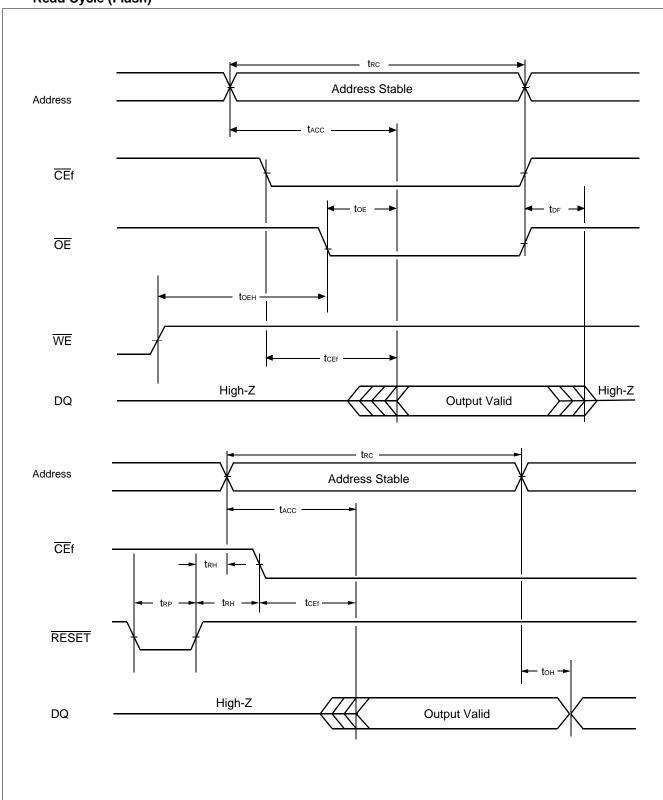
• Write/Erase/Program Operations

Myrite Cycle Time		.	Syn	nbols		Value		
Address Setup Time to OE Low During Toggle Bit Community Toggle Bit Polling Community Toggle Bit Polling Toggle Bit Polling Community Toggle Bit Polling Toggle Bit		Parameter	JEDEC	Standard	Min	Тур	Max	Unit
Address Setup Time to OE Low During Toggle Bit Polling	Write Cycle Time		tavav	twc	70	_	_	ns
Polling	Address Setup Time		tavwl	t AS	0	_	_	ns
Address Hold Time from CEf or OE High During Toggle Bit Polling		ne to OE Low During Toggle Bit	_	taso	12	_		ns
Toggle Bit Polling	Address Hold Time	9	twlax	t ah	45	_	_	ns
Data Hold Time		e from CEf or OE High During	_	t aht	0	_		ns
Output Enable Hold Time Read Toggle and Data Polling — toeH 10 — — ns ŒFf High During Toggle Bit Polling — tcePH 20 — — ns ŒF High During Toggle Bit Polling — tcePH 20 — — ns Read Recover Time Before Write tchHwL tchHwL 0 — — ns Read Recover Time Before Write tchHuL tchHuL 0 — — ns Read Recover Time Before Write tchHuL tchHuL 0 — — ns Read Recover Time Before Write tchHuL tchHuL 0 — — ns Read Recover Time Before Write tchHuL tchHuL 0 — — ns CEf Setup Time tchHuL tcs 0 — — ns WE Setup Time tchHuL twh 0 — — ns Write Pulse Width High tchHuL twh 25 — <td>Data Setup Time</td> <td></td> <td>tdvwh</td> <td>tDS</td> <td>30</td> <td></td> <td>_</td> <td>ns</td>	Data Setup Time		t dvwh	t DS	30		_	ns
Hold Time Toggle and Data Polling Toggle Bit	Data Hold Time		twndx	tон	0		_	ns
Floid Time Toggle and Data Polling 10		Read		toru	0		_	ns
ÖE High During Toggle Bit Polling — toeph 20 — ns Read Recover Time Before Write tshwl tshwl 0 — ns Read Recover Time Before Write tshell tshell 0 — — ns CEf Setup Time tslwl tslwl 0 — — ns CEf Hold Time twl twl 0 — — ns WE Hold Time twl tol 0 — — ns WE Hold Time tshwh tol — — ns WF Hold Time tshwh twn 0 — — ns Write Pulse Width tswwh 35 — — ns CEf Pulse Width High tsle tsle — ns Verite Pulse Width High tsle tsle — ns Sector Erase Operation *1 twn tsle twn 25 — ns Verit Setup Time <td< td=""><td>Hold Time</td><td>Toggle and Data Polling</td><td></td><td>LOEH</td><td>10</td><td>_</td><td>_</td><td>ns</td></td<>	Hold Time	Toggle and Data Polling		L OEH	10	_	_	ns
Read Recover Time Before Write to HML to HML 0 — ns Read Recover Time Before Write to HELL to HELL 0 — — ns ŒEf Setup Time tellul tos 0 — — ns WE Setup Time twlLeL tws 0 — — ns ŒEf Hold Time twlLeL tws 0 — — ns WE Hold Time twlHell tch 0 — — ns WE Hold Time twlHell tch 0 — — ns WE Hold Time twlHell twh 0 — — ns Wifte Pulse Width twlLeL twh 0 — — ns Write Pulse Width High twlLeL twp 35 — — ns Write Pulse Width High twh twh 25 — ns Sector Erase Operation *1 twh twh 25 <td< td=""><td>CEf High During To</td><td>oggle Bit Polling</td><td>_</td><td>tCEPH</td><td>20</td><td>_</td><td>_</td><td>ns</td></td<>	CEf High During To	oggle Bit Polling	_	t CEPH	20	_	_	ns
Read Recover Time Before Write to HeL to HeL to HeL 0 — ns CEf Setup Time telw tcs 0 — ns WE Setup Time twlet tws 0 — ns CEf Hold Time twheth tch 0 — ns WE Hold Time tehwh twh 0 — ns Write Pulse Width twh 0 — ns Write Pulse Width twh 0 — ns Write Pulse Width High twh 25 — ns Sector Erase Operation *1 twhwh 25 — ns Sector Erase Operation *1 twhwh twh 25 — ns Sector Erase Operation *1 twhwh twh 25 — ns Sector Erase Operation *1 twhwh twh 25 — ns Sector Erase Operation *1 twh twh 25 — ns Rise Time	OE High During To	oggle Bit Polling	_	t oeph	20			ns
CEf Setup Time telw. tcs 0 — — ns WE Setup Time twlel tws 0 — — ns CEf Hold Time twheh tch 0 — — ns WE Hold Time tehwh twh 0 — — ns Write Pulse Width tehwh twh 0 — — ns CEf Pulse Width twh twh 0 — — ns Write Pulse Width telleh tcp 35 — — ns Write Pulse Width High twhwh twh 25 — ns ns Sector Erase Operation *1 twhwh twh 25 — ns ns Sector Erase Operation *1 twhwh twh 25 — ns ns Sector Erase Operation *1 twhwh twh 25 — ns Sector Erase Operation *1 twhwh twh 25	Read Recover Tim	e Before Write	t GHWL	t GHWL	0			ns
WE Setup Time twlet tws 0 — ns CEf Hold Time twheh tch 0 — ns WE Hold Time tehwh twh 0 — ns Write Pulse Width twh 0 — ns Write Pulse Width High twh 25 — ns Sector Erase Operation *1 twh 25 — ns Sector Erase Operation *1 twh twh 25 — ns Sector Erase Operation *1 twh twh 25 — ns Sector Erase Operation *1 twh twh 25 — ns Rise Time to Vio *2 — twh 25 — ns Rise Time to Vio *2 — twh 500 —	Read Recover Tim	e Before Write	t GHEL	t GHEL	0			ns
CEf Hold Time twhen tch 0 — ns WE Hold Time tehwh twh 0 — ns Write Pulse Width twhwh twp 35 — ns CEf Pulse Width High twhw. twhw. twp 25 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Sector Erase Operation *1 twhwhz twhwhz — 0.5 — ns Rise Time to Vio *2 — twlp 25 — ns Rise Time to Vio *2 — <td< td=""><td>CEf Setup Time</td><td></td><td>telwl</td><td>tcs</td><td>0</td><td></td><td></td><td>ns</td></td<>	CEf Setup Time		telwl	t cs	0			ns
WE Hold Time tehwh twh 0 — — ns Write Pulse Width twhwh twhwh 35 — — ns Œf Pulse Width teleh tcp 35 — — ns Write Pulse Width High twhwh twhwh 25 — — ns Ector Erase Operation *1 twhwh twhwh — 0.5 — ns Sector Erase Operation *1 twhwh twhwh — 0.5 — ns Sector Erase Operation *1 twhwh 50 — — ns Sector Erase Operation *1 twhwh 50 — — ns Sector Erase Operation *1 twhwh 50 — — ns Vocf Setup Time — tvcs 50 — — µs Rise Time to Vio *2 — twh 500 — — ns Voltage Transition Time *2 — twp twp 100<	WE Setup Time		twlel	tws	0			ns
Write Pulse Width twlwh twp 35 — ns CEf Pulse Width teleh tcp 35 — ns Write Pulse Width High twhwl twh 25 — ns CEf Pulse Width High tehel tcph 25 — ns Sector Erase Operation *1 twhwh2 twhwh2 — 0.5 — s Vcof Setup Time — tvcs 50 — — μs Rise Time to Vio *2 — tvaccr 500 — ns Rise Time to Vio *2 — tvaccr 500 — ns Voltage Transition Time *2 — tvlh 4 — — μs Write Pulse Width *2 — twpp 100 — — μs OE Setup Time to WE Active *2 — tcsp 4 — — μs CEf Setup Time to WE Active *2 — tcsp 4 — — μs	CEf Hold Time		twheh	t cH	0	_	_	ns
CEf Pulse Width teleh top 35 — ns Write Pulse Width High twhwL twhwL twph 25 — ns CEf Pulse Width High tehel tcph 25 — ns Sector Erase Operation *1 twhwH2 twhwH2 — 0.5 — ns Sector Erase Operation *1 twhwH2 twhwH2 — 0.5 — s Vcof Setup Time — tvcs 50 — — ys Rise Time to Vide *2 — tvlace 500 — — ns Rise Time to Vide *2 — tvlace 500 — — ns Voltage Transition Time *2 — twh 100 — — ns Write Pulse Width *2 — twp 100 — — µs OE Setup Time to WE Active *2 — tcsp 4 — — µs Recover Time from RY/BY — trap	WE Hold Time		tehwh	twн	0	_	_	ns
Write Pulse Width High twнwL twнwL twpн 25 — ns CEf Pulse Width High tehel tcph 25 — ns Sector Erase Operation *1 twhwh2 twhwh2 — 0.5 — s Vccf Setup Time — tvcs 50 — — µs Rise Time to Vid *2 — tvide 500 — — ns Rise Time to Vide *2 — tvaccr 500 — — ns Voltage Transition Time *2 — tvlht 4 — — µs Voltage Transition Time *2 — twpp 100 — — ns Write Pulse Width *2 — twpp 100 — — µs OE Setup Time to WE Active *2 — tcsp 4 — — µs CEf Setup Time to WE Active *2 — trsp 4 — — µs RESET Pulse Width <	Write Pulse Width		twlwh	t wp	35			ns
CEf Pulse Width High tehen tcph 25 — ns Sector Erase Operation *1 twhwh2 twhwh2 — 0.5 — s Vccf Setup Time — tvcs 50 — — μs Rise Time to Vid *2 — tvlde 500 — — ns Voltage Transition Time *2 — tvlt 4 — — μs Vrite Pulse Width *2 — twpp 100 — — μs OE Setup Time to WE Active *2 — tossp 4 — — μs Cef Setup Time from RY/BY — trs 0 — ns RESET Pulse Width — trs 500 — ns RESET High Level Period before Read — trs 200 — ns Program/Erase Valid to RY/BY Delay — tbusy — 90 ns Delay Time from Embedded Output Enable — trow 50 —	CEf Pulse Width		t ELEH	t CP	35			ns
Sector Erase Operation *1 twhwh2 twhwh2	Write Pulse Width	High	twhwl	t wph	25		_	ns
Vccf Setup Time — tvcs 50 — μs Rise Time to V₁0 *2 — tvлccr 500 — ns Rise Time to V₁0 *2 — tvлccr 500 — ns Voltage Transition Time *2 — tvlнт 4 — μs Write Pulse Width *2 — twpp 100 — μs OE Setup Time to WE Active *2 — tossp 4 — μs CEf Setup Time to WE Active *2 — tcsp 4 — μs Recover Time from RY/BY — trsb 0 — ns RESET Pulse Width — trsb 500 — ns RESET High Level Period before Read — trsh 200 — ns Program/Erase Valid to RY/BY Delay — tsusy — 90 ns Delay Time from Embedded Output Enable — tsoe — — 70 ns Erase Time-Out Time —	CEf Pulse Width H	ligh	tehel	t CPH	25		_	ns
Rise Time to V _{ID} *2 — tvIDR 500 — — ns Rise Time to V _{ID} *2 — tvACCR 500 — — ns Voltage Transition Time *2 — tvLHT 4 — — µs Write Pulse Width *2 — twPP 100 — — µs ŌE Setup Time to WE Active *2 — toEsP 4 — — µs CEf Setup Time from RY/BY — trs 0 — — ns RESET Pulse Width — trs 500 — — ns RESET High Level Period before Read — trн 200 — ns Program/Erase Valid to RY/BY Delay — tbusy — 90 ns Delay Time from Embedded Output Enable — teoe — — µs Erase Time-Out Time — trow 50 — — µs	Sector Erase Oper	ration *1	twhwh2	twhwh2		0.5		S
Rise Time to V _{ID} *2	Vccf Setup Time		_	tvcs	50	_	_	μs
Voltage Transition Time *2 — tvlht 4 — — μs Write Pulse Width *2 — twpp 100 — — μs ŌĒ Setup Time to WĒ Active *2 — tosp 4 — — μs Recover Time from RY/BY — trab 0 — — ns RĒSĒT Pulse Width — trab 500 — — ns RĒSĒT High Level Period before Read — trh 200 — — ns Program/Ērase Valid to RY/BY Delay — tbusy — 90 ns Delay Time from Embedded Output Enable — teoe — — μs Erase Time-Out Time — trow 50 — — μs	Rise Time to V _{ID} *2		_	tvidr	500	_	_	ns
Write Pulse Width *2 — twpp 100 — μs OE Setup Time to WE Active *2 — toesp 4 — μs CEf Setup Time to WE Active *2 — tcsp 4 — μs Recover Time from RY/BY — tree 0 — ns RESET Pulse Width — tree 500 — ns RESET High Level Period before Read — tree 200 — ns Program/Erase Valid to RY/BY Delay — tbusy — 90 ns Delay Time from Embedded Output Enable — teoe — 70 ns Erase Time-Out Time — trow 50 — — μs	Rise Time to V _{ID} *2		_	tvaccr	500		_	ns
Write Pulse Width *2 — twpp 100 — μs OE Setup Time to WE Active *2 — toesp 4 — μs CEf Setup Time to WE Active *2 — tcsp 4 — μs Recover Time from RY/BY — tree 0 — ns RESET Pulse Width — tree 500 — ns RESET High Level Period before Read — tree 200 — ns Program/Erase Valid to RY/BY Delay — tbusy — 90 ns Delay Time from Embedded Output Enable — teoe — 70 ns Erase Time-Out Time — trow 50 — — μs	Voltage Transition	Time *2	_	t vlht	4		_	μs
CEf Setup Time to WE Active *2 — tcsp 4 — μs Recover Time from RY/BY — trb 0 — ns RESET Pulse Width — trp 500 — ns RESET High Level Period before Read — trp 200 — ns Program/Erase Valid to RY/BY Delay — trow — 90 ns Delay Time from Embedded Output Enable — trow 50 — — μs Erase Time-Out Time — trow 50 — — μs			_	t wpp	100			μs
Recover Time from RY/BY — trb 0 — ns RESET Pulse Width — trp 500 — — ns RESET High Level Period before Read — trp 200 — — ns Program/Erase Valid to RY/BY Delay — trow — 90 ns Delay Time from Embedded Output Enable — trow 50 — μs Erase Time-Out Time — trow 50 — μs	OE Setup Time to	WE Active *2	_	toesp	4			μs
RESET Pulse Width — tRP 500 — — ns RESET High Level Period before Read — tRH 200 — — ns Program/Erase Valid to RY/BY Delay — tBUSY — 90 ns Delay Time from Embedded Output Enable — tEOE — — 70 ns Erase Time-Out Time — trow 50 — μs	CEf Setup Time to WE Active *2		_	tcsp	4			μs
RESET High Level Period before Read — tRH 200 — — ns Program/Erase Valid to RY/BY Delay — tBUSY — 90 ns Delay Time from Embedded Output Enable — tEOE — 70 ns Erase Time-Out Time — trow 50 — μs	Recover Time from RY/BY		_	t RB	0			ns
RESET High Level Period before Read — tRH 200 — — ns Program/Erase Valid to RY/BY Delay — tBUSY — 90 ns Delay Time from Embedded Output Enable — tEOE — 70 ns Erase Time-Out Time — trow 50 — μs	RESET Pulse Width		_	t RP	500	_	_	ns
Program/Erase Valid to RY/BY Delay — t _{BUSY} — 90 ns Delay Time from Embedded Output Enable — t _{EOE} — — 70 ns Erase Time-Out Time — t _{TOW} 50 — μs	RESET High Level Period before Read		_	t RH		_	_	ns
Delay Time from Embedded Output Enable — teoe — 70 ns Erase Time-Out Time — trow 50 — μs			_				90	
Erase Time-Out Time — trow 50 — µs		<u> </u>	_					
		<u> </u>	_		50	_	_	
			_	tspd		_	20	μs

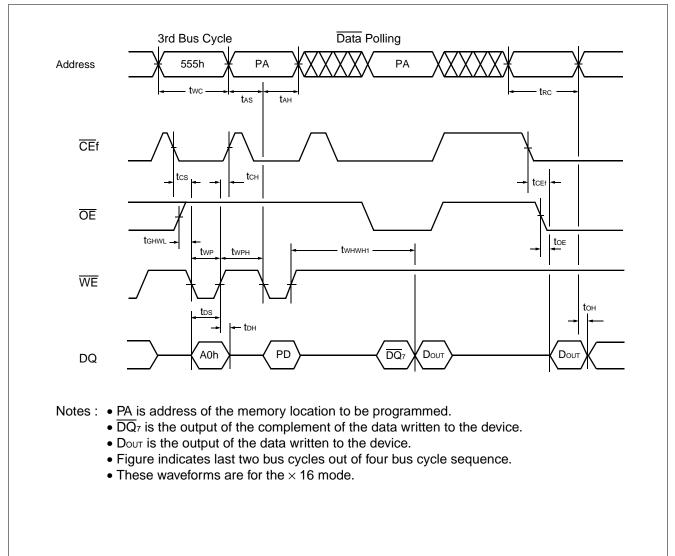
^{*1:} This does not include the preprogramming time.

^{*2:} This timing is for Sector Group Protection operation.

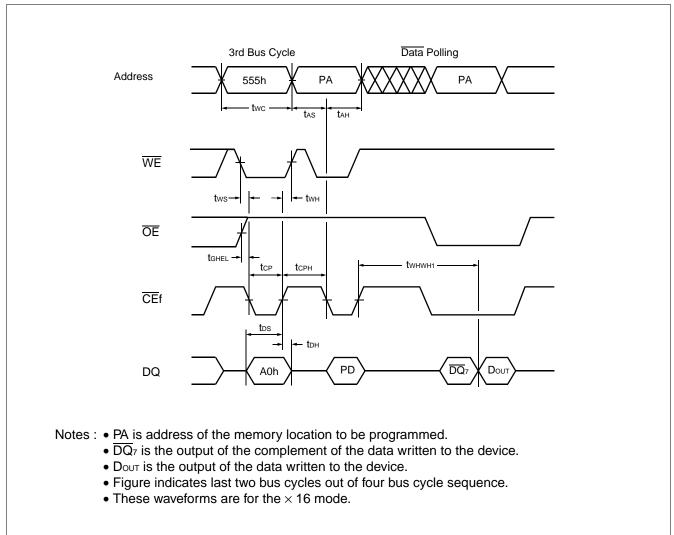
• Read Cycle (Flash)



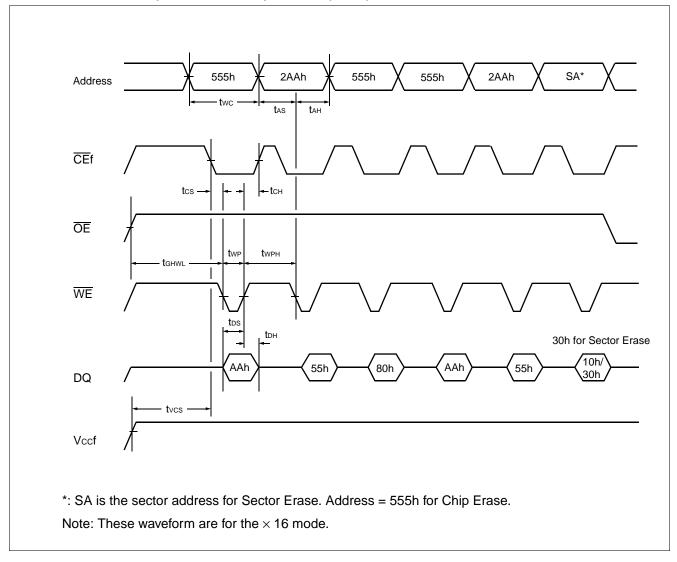
• Write Cycle (WE control) (Flash)



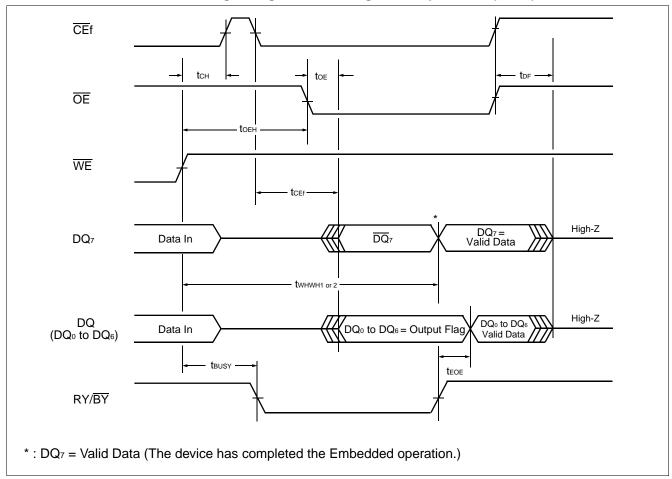
• Write Cycle (CEf control) (Flash)



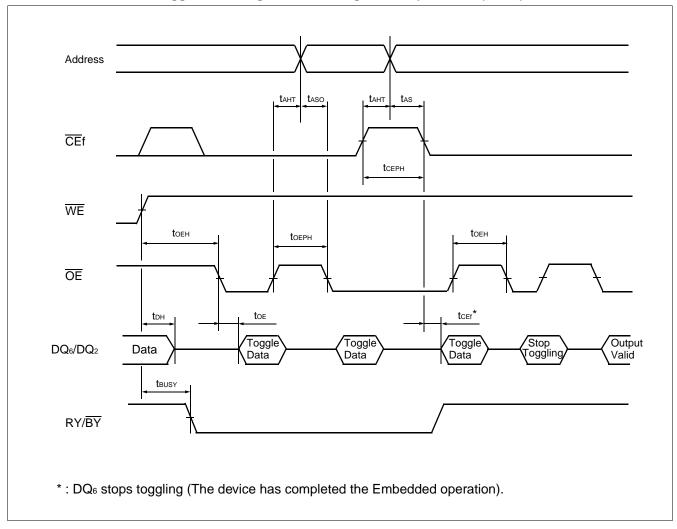
• AC Waveforms Chip/Sector Erase Operations (Flash)



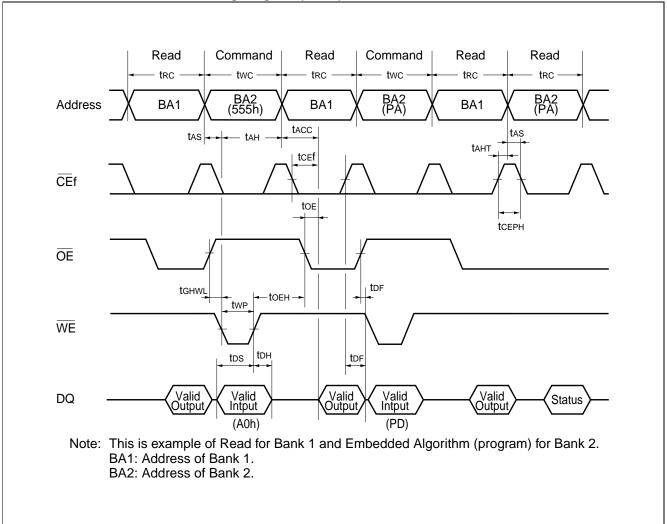
• AC Waveforms for Data Polling during Embedded Algorithm Operations (Flash)



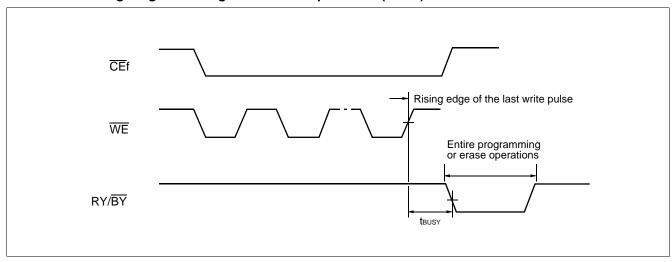
• AC Waveforms for Toggle Bit during Embedded Algorithm Operations (Flash)



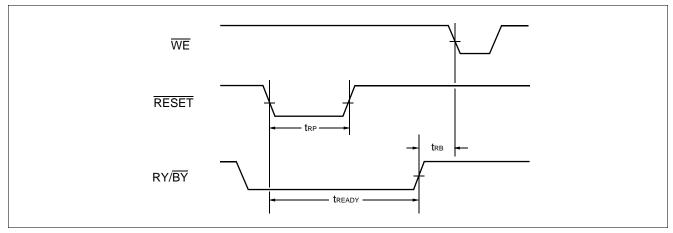
Bank-to-bank Read/Write Timing Diagram (Flash)



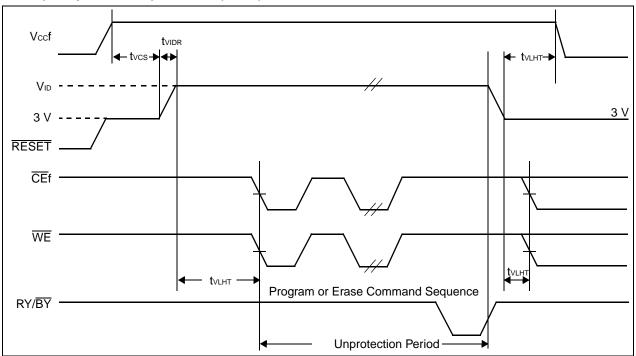
• RY/BY Timing Diagram during Write/Erase Operations (Flash)



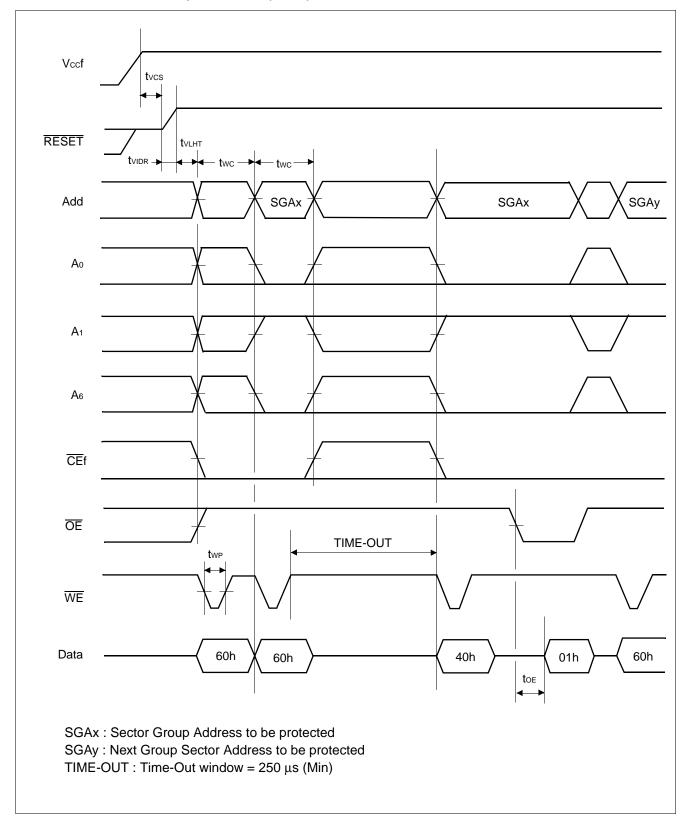
• RESET, RY/BY Timing Diagram (Flash)



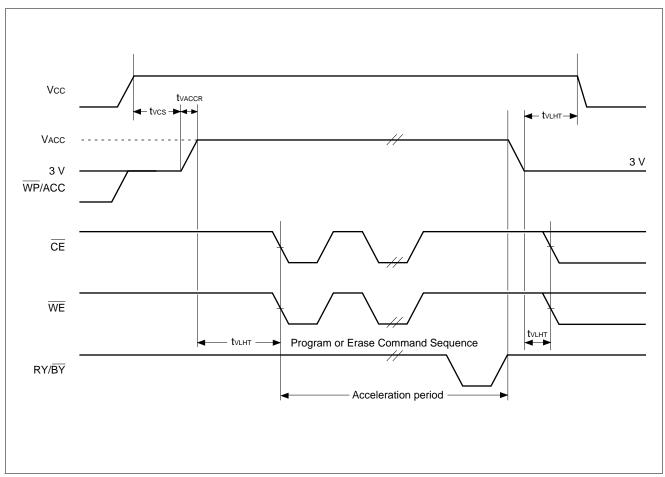
• Temporary Sector Unprotection (Flash)



• Extended Sector Group Protection (Flash)



• Accelerated Program (Flash)



3. Erase and Programming Performance

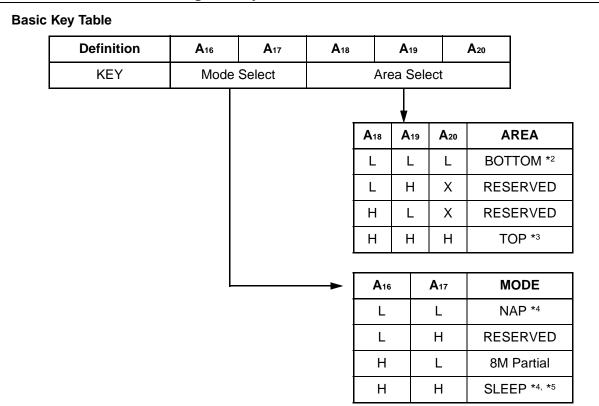
Parameter		Limits		Unit	Comments		
raiailletei	Min Typ		Max	Oilit	Comments		
Sector Erase Time		0.5	2.0	S	Excludes programming time prior to erasure		
Word Programming Time	_	6.0	100	μs	Excludes system-level overhead		
Chip Programming Time	_	_	100	S	Excludes system-level overhead		
Program/Erase Cycle	100,000		_	cycle	_		

Notes: • Typical erase conditions $T_A = +25$ °C, $V_{CC} = 2.9 \text{ V}$

• Typical program conditions T_A = +25 °C, V_{CC} = 2.9 V, Data = Checker

■ 32M FCRAM CHARACTERISTICS for MCP

1. FCRAM Power Down Program Key Table



Available Key Table

MODE	A 16	A 17	A 18	A 19	A 20	Data Retention
WIODL	Mode Select		Area Select			Area
NAP	L	L	Х	Х	Х	None
8M Partial	Н	L	L	L	L	Bottom 8M only
OIVI Partial	Н	L	Н	Н	Н	Top 8M only
SLEEP	Н	Н	Х	Х	Х	None

- *1: The Power Down Program can be performed one time after compliance of Power-up timings and it should not be re-programmed after regular Read or Write.
 - Unspecified addresses, A_{15} to A_0 , can be either High or Low during the programming. The RESERVED key should not be used.
- *2: BOTTOM area is from the lowest address location. (i.e., A_{20} to $A_0 = L$)
- *3: TOP area is from the highest address location. (i.e., A_{20} to $A_0 = H$)
- *4: NAP and SLEEP do not retain the data and Area Select is ignored.
- *5: Default state. Power Down Program to this SLEEP mode can be omitted.

2. AC Characteristics (FCRAM)READ OPERATION (FCRAM)

Dovernator	Cumbal	V	alue	11:4	Damarka	
Parameter	Symbol	Min	Max	Unit	Remarks	
Read Cycle Time	t RC	70	_	ns		
Chip Enable Access Time	t ce	_	65	ns	*1,*3	
Output Enable Access Time	toe	_	40	ns	*1	
Address Access Time	t AA	_	65	ns	*1,*4	
Output Data Hold Time	tон	5	_	ns	*1	
CE1r Low to Output Low-Z	t clz	5	_	ns	*2	
OE Low to Output Low-Z	tolz	0	_	ns	*2	
CE1r High to Output High-Z	tснz	_	20	ns	*2	
OE High to Output High-Z	tонz	_	20	ns	*2	
Address Setup Time to CE1r Low	tasc	- 5	_	ns	*5	
Address Setup Time to OE	taso	25	_	ns	*3,*6	
	taso(abs)	10	_	ns	*7	
LB / UB Setup Time to CE1r Low	t BSC	- 5	_	ns	*5	
LB / UB Setup Time to OE Low	t BSO	10	_	ns		
Address Invalid Time	tax	_	5	ns	*4,*8	
Address Hold Time from CE1r Low	t CLAH	70	_	ns	*4	
Address Hold Time from OE Low	t olah	45	_	ns	*4,*9	
Address Hold Time from CE1r High	t CHAH	– 5	_	ns		
Address Hold Time from OE High	tонан	– 5	_	ns		
LB / UB Hold Time from CE1r High	tснвн	– 5	_	ns		
LB / UB Hold Time from OE High	tонвн	– 5	_	ns		
CE1r Low to OE Low Delay Time	tclol	25	1000	ns	*3,*6,*9,*10	
OE Low to CE1r High Delay Time	t olch	45	_	ns	*9	
CE1r High Pulse Width	t CP	12	_	ns		
OE High Bulgo Width	top	25	1000	ns	*6,*9,*10	
OE High Pulse Width	top(ABS)	12	_	ns	*7	

- *1: The output load is 30 pF.
- *2: The output load is 5 pF.
- *3: The tce is applicable if \overline{OE} is brought to Low before $\overline{CE1}$ r goes Low and is also applicable if actual value of both or either taso or tclol is shorter than specified value.
- *4: Applicable only to A₁ and A₀ when both CE1r and OE are kept at Low for the address access.
- *5: Applicable if \overline{OE} is brought to Low before $\overline{CE1}$ r goes Low.
- *6: The taso, tclol(Min) and top(Min) are reference values when the access time is determined by toe. If actual value of each parameter is shorter than specified minimum value, toe become longer by the amount of subtracting actual value from specified minimum value. For example, if actual taso, taso(actual), is shorter than specified minimum value, taso(Min), during OE control access (i.e., CE1r stays Low), the toe become toe(Max) + taso(Min) taso(actual).
- *7: The taso(ABS) and top(ABS) is the absolute minimum value during OE control access.
- *8: The tax is applicable when both A₁ and A₀ are switched from previous state.
- *9: If actual value of either tclol or top is shorter than specified minimum value, both tolah and tolch become trc(Min) tclol(actual) or trc(Min) top(actual).
- *10 : Maximum value is applicable if CE1r is kept at Low.

WRITE OPERATION (FCRAM)

Doromotor	Symbol	Va	lue	Unit	Remarks
Parameter	Symbol	Min	Max	Unit	Remarks
Write Cycle Time	t wc	70	_	ns	*1
Address Setup Time	t as	0	_	ns	*2
Address Hold Time	t ah	35	_	ns	*2
CE1r Write Setup Time	t cs	0	1000	ns	
CE1r Write Hold Time	tсн	0	1000	ns	
WE Setup Time	tws	0	_	ns	
WE Hold Time	twн	0	_	ns	
LB and UB Setup Time	t BS	- 5	_	ns	
LB and UB Hold Time	tвн	- 5	_	ns	
OE Setup Time	toes	0	1000	ns	*3
OE Hold Time	t oeh	25	1000	ns	*3, *4
OE Hold Tillle	toeh(ABS)	12	_	ns	*5
OE High to CE1r Low Setup Time	toncl	- 5	_	ns	*6
OE High to Address Hold Time	t ohah	- 5	_	ns	*7
CE1r Write Pulse Width	tcw	45	_	ns	*1, *8
WE Write Pulse Width	t wp	45	_	ns	*1, *8
CE1r Write Recovery Time	twrc	10	_	ns	*1, *9
WE Write Recovery Time	t wr	10	1000	ns	*1, *3, *9
Data Setup Time	tos	15	_	ns	
Data Hold Time	tон	0	_	ns	
CE1r High Pulse Width	t cp	12	_	ns	*9

^{*1 :} Minimum value must be equal or greater then the sum of actual tcw (or twp) and twac (or twa).

^{*2 :} New write address is valid from either CE1r or WE is bought to High.

^{*3:} The toeh is specified from end of twc(Min). The toeh(Min) is a reference value when the access time is determined by toe. If actual value, toeh(actual) is shorter than specified minimum value, toehecome longer by the amount of subtracting actual value from specified minimum value.

^{*4 :} The toeh(Max) is applicable if $\overline{CE1}$ r is kept at Low and both \overline{WE} and \overline{OE} are kept at High.

^{*5 :} The toeh(ABS) is the absolute minimum value if write cycle is terminated by WE and CE1r stays Low.

^{*6:} tohcl(Min) must be satisfied if read operation is not performed prior to write operation.

In case \overline{OE} is disabled after tohcl(Min), \overline{WE} Low must be asserted after trc(Min) from $\overline{CE1}$ r Low.

In other words, read operation is initiated if tohcl (Min) is not satisfied.

^{*7 :} Applicable if CE1r stays Low after read operation.

^{*8 :} tcw and two is applicable if write operation is initiated by $\overline{CE1}r$ and \overline{WE} , respectively.

^{*9 :} twrc and twr is applicable if write operation is terminated by $\overline{CE1}r$ and \overline{WE} , respectively. The twr(Min) can be ignored if $\overline{CE1}r$ is brought to High together or after \overline{WE} is brought to High. In such case, the tcp(Min) must be satisfied.

• POWER DOWN and POWER DOWN PROGRAM PARAMETERS (FCRAM)

Parameter	Symbol	Va	lue	Unit	Remarks
rai ametei	Symbol	Min	Max	Unit	Remarks
CE2r Low Setup Time for Power Down Entry	t csp	10	_	ns	
CE2r Low Hold Time after Power Down Entry	t _{C2LP}	70	_	ns	
CE1r High Hold Time following CE2r High after Power Down Exit (SLEEP mode only)	tснн	350	_	μs	
CE1r High Setup Time following CE2r High after Power Down Exit (Except for SLEEP mode)	tснни	1	_	μs	
CE1r High Setup Time following CE2r High after Power Down Exit	t chs	10	_	ns	
CE1r High to PE Low Setup Time	t EPS	70	_	ns	*
PE Power Down Program Pulse Width	t EP	70	_	ns	*
PE High to CE1r Low Hold Time	t eph	70	_	ns	*
Address Setup Time to PE High	t EAS	15	_	ns	*
Address Setup Time from PE High	t EAH	0	_	ns	*

^{*:} Applicable to Power Down Program.

• OTHER TIMING PARAMETERS (FCRAM)

Parameter	Symbol	Va	lue	Unit	Remarks
Farameter	Зуньон	Min	Max	Oilit	Remarks
CE1r High to OE Invalid Time for Standby Entry	t cнox	10	_	ns	
CE1r High to WE Invalid Time for Standby Entry	t chwx	10	_	ns	*1
CE2r Low Hold Time after Power-up	t C2LH	50	_	μs	*2
CE2r High Hold Time after Power-up	tc2HL	50	_	μs	*3
CE1r High Hold Time following CE2r High after Power-up	tснн	350	_	μs	*2
Input Transition Time	t⊤	1	25	ns	*4

^{*1:} It may write some data into any address location if tchwx is not satisfied.

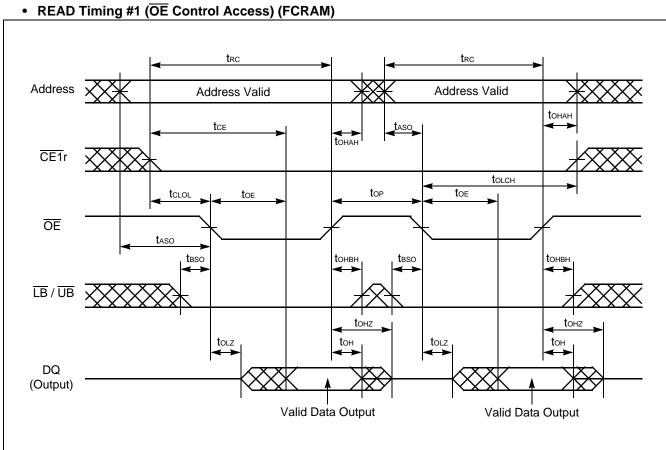
• AC TEST CONDITIONS (FCRAM)

Description	Symbol	Test Setup	Value	Unit	Remarks
Input High Level	ViH	Vccr = 2.7 V to 3.1 V	2.3	V	
Input Low Level	VIL	Vccr = 2.7 V to 3.1 V	0.4	V	
Input Timing Measurement Level	V _{REF}	Vccr = 2.7 V to 3.1 V	1.3	V	
Input Transition Time	t⊤	Between V _I L and V _I H	5	ns	

^{*2:} Must satisfy tchH(Min) after tc2LH(Min).

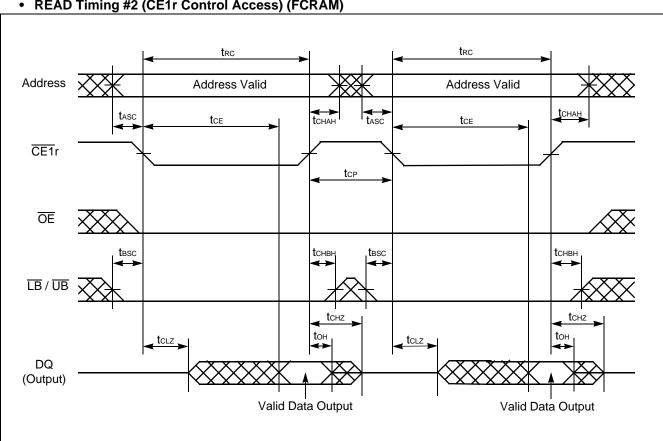
^{*3:} Requires Power Down mode entry and exit after tc2HL.

^{*4:} The input Transition Time (tτ) at AC testing is 5 ns as shown in below. If actual tτ is longer than 5ns, it may violate AC specification of some timing parameters.



Note: CE2r, $\overline{\text{PE}}$ and $\overline{\text{WE}}$ must be High for entire read cycle.

Either or both $\overline{\text{LB}}$ and $\overline{\text{UB}}$ must be Low when both $\overline{\text{CE1}}$ r and $\overline{\text{OE}}$ are Low.



• READ Timing #2 (CE1r Control Access) (FCRAM)

Note : CE2r, $\overline{\text{PE}}$ and $\overline{\text{WE}}$ must be High for entire read cycle. Either or both $\overline{\text{LB}}$ and $\overline{\text{UB}}$ must be Low when both $\overline{\text{CE1r}}$ and $\overline{\text{OE}}$ are Low.

trc Address Address Valid Address Valid (No change) (A₂₀ to A₃) Address Address Valid Address Valid (A₂ to A₀) **t**OHAH **t**olah CE1r **t**oe tohz OE **t**BSO $\overline{\mathsf{LB}}\,/\,\overline{\mathsf{UB}}$ tolz ≺≻ tон tон DQ (Output) Valid Data Output Valid Data Output

• READ Timing #3 (Address Access after OE Control Access) (FCRAM)

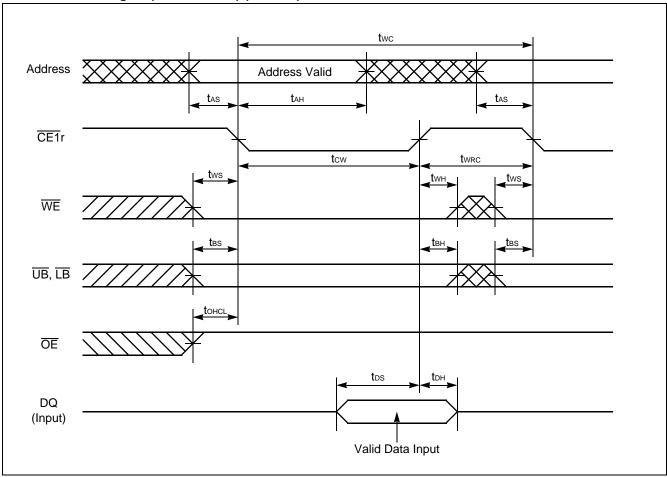
Note : CE2r, $\overline{\text{PE}}$ and $\overline{\text{WE}}$ must be High for entire read cycle. Either or both $\overline{\text{LB}}$ and $\overline{\text{UB}}$ must be Low when both $\overline{\text{CE1r}}$ and $\overline{\text{OE}}$ are Low.

tRC Address Address Valid Address Valid (No change) (A₂₀ to A₃) Address Address Valid Address Valid (A₂ to A₀) **t**CHAH tCLAH CE1r **t**ce **t**cHZ OE $\overline{\mathsf{LB}}\,/\,\overline{\mathsf{UB}}$ tон tон **t**clz DQ (Output) Valid Data Output Valid Data Output

• READ Timing #4 (Address Access after CE1r Control Access) (FCRAM)

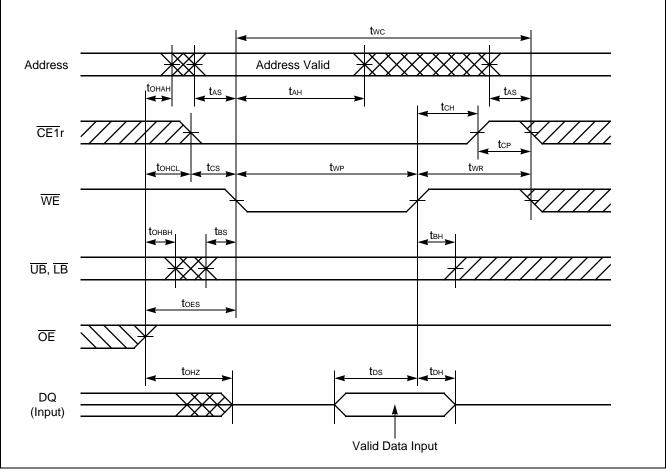
Note : CE2r, $\overline{\text{PE}}$ and $\overline{\text{WE}}$ must be High for entire read cycle. Either or both \overline{LB} and \overline{UB} must be Low when both $\overline{CE1}$ r and \overline{OE} are Low.

• WRITE Timing #1 (CE1r Control) (FCRAM)



Note : CE2r and $\overline{\text{PE}}$ must be High for write cycle.

• WRITE Timing #2-1 (WE Control, Single Write Operation) (FCRAM)



Note: CE2r and PE must be High for write cycle.

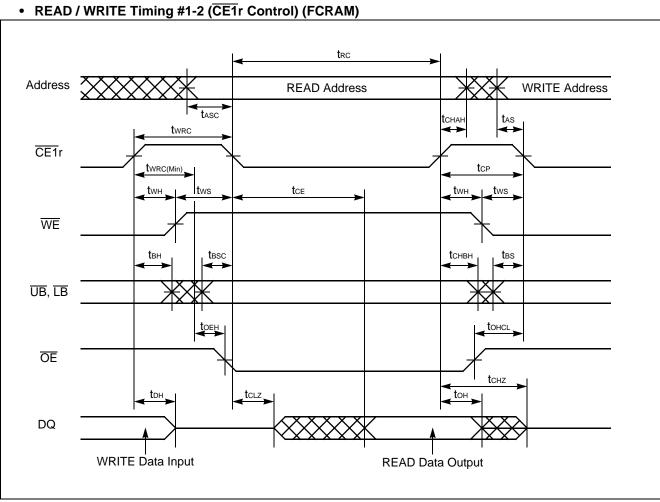
Address Address Valid tонан **t**AS \mathbf{t}_{AH} CE1r t_{WP} twR $\overline{\text{WE}}$ $\overline{\text{UB}}, \overline{\text{LB}}$ toes ŌĒ **t**onz DQ (Input) Valid Data Input

• WRITE Timing #2-2 (WE Control, Continuous Write Operation) (FCRAM)

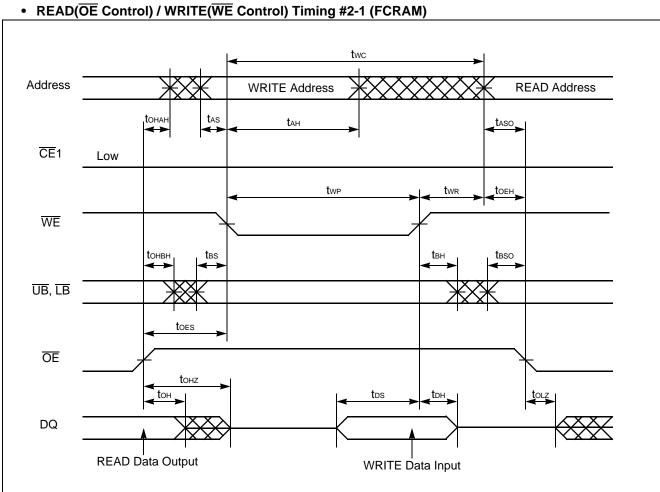
Note : CE2r and $\overline{\text{PE}}$ must be High for write cycle.

• READ / WRITE Timing #1-1 (CE1r Control) (FCRAM) twc Address WRITE Address **READ Address** tchah ▼ ➤ tas **≺** ➤ \mathbf{t}_{AH} CE1r $t_{\sf CP}$ t_{WRC} tcw $\overline{\mathsf{WE}}$ **t**CHBH **t**BS tBSO tвн $\overline{\mathsf{UB}}, \overline{\mathsf{LB}}$ toncl OE **t**cHZ tон ton, tolz DQ **READ Data Output** WRITE Data Input

Note: Write address is valid from either $\overline{CE1}r$ or \overline{WE} of last falling edge.



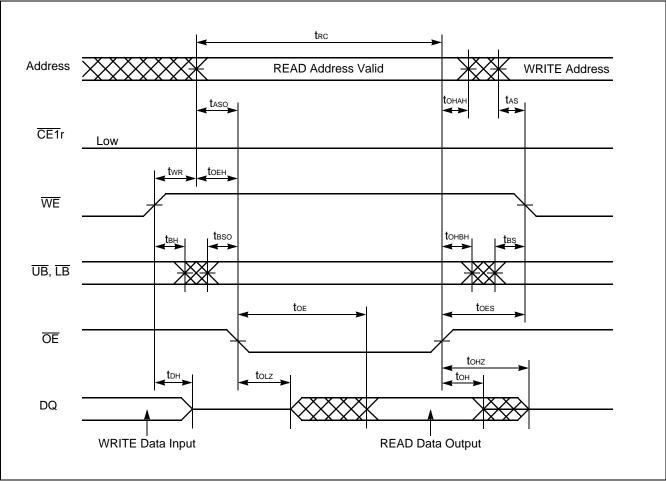
Note: The toeh is specified from the time satisfied both twrc and twr(Min).



When $\overline{\text{CE1}}\text{r}$ is tied to Low, output is exclusively controlled by $\overline{\text{OE}}$.

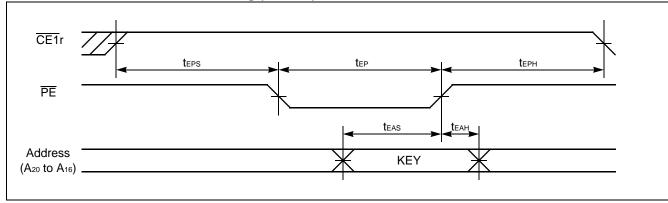
Note : $\overline{CE1}r$ can be tied to Low for \overline{WE} and \overline{OE} controlled operation.





Note: $\overline{\text{CE1}}$ r can be tied to Low for $\overline{\text{WE}}$ and $\overline{\text{OE}}$ controlled operation. When $\overline{\text{CE1}}$ r is tied to Low, output is exclusively controlled by $\overline{\text{OE}}$.

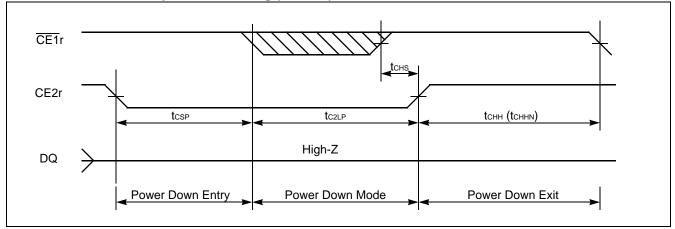
• POWER DOWN PROGRAM Timing (FCRAM)



Note: CE2r must be High for Power Down Programming.

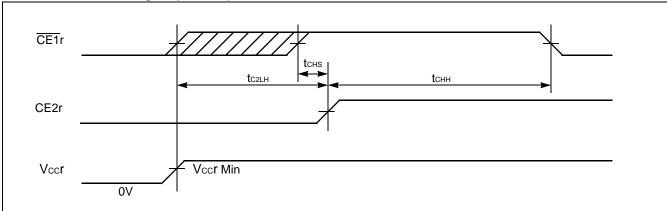
Any other inputs not specified above can be either High or Low.

• POWER DOWN Entry and Exit Timing (FCRAM)



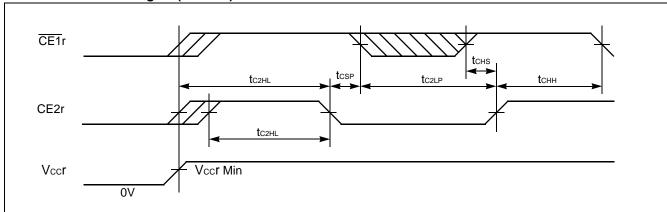
Note: This Power Down mode can be also used for Power-up #2 below except that tchhn can not be used at Power-up timing.

• POWER-UP Timing #1 (FCRAM)



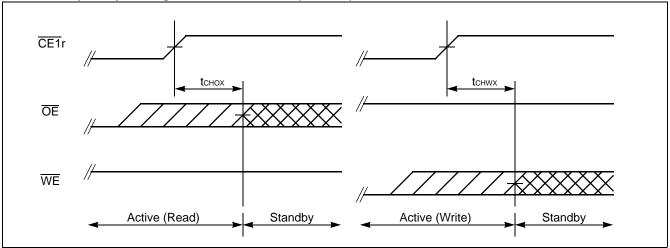
Note: The tc2LH specifies after Vccr reaches specified minimum level.

• POWER-UP Timing #2 (FCRAM)



Note: The t_{C2HL} specifies from CE2r Low to High transition after V_{CCT} reaches specified minimum level. $\overline{CE1}r$ must be brought to High prior to or together with CE2r Low to High transition.

• Standby Entry Timing after Read or Write (FCRAM)



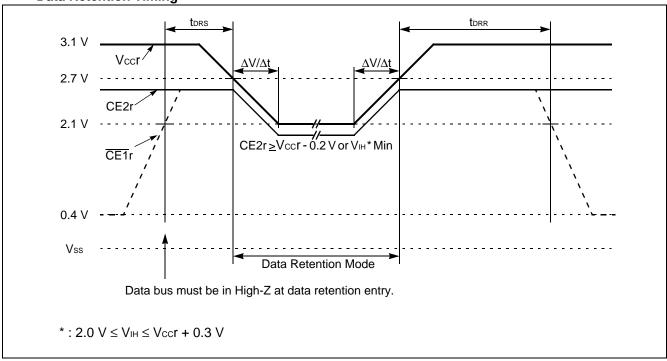
Note: Both t_{CHOX} and t_{CHWX} define the earliest entry timing for Standby mode. If either of timing is not satisfied, it takes t_{RC} (Min) period from either last address transition of A_1 and A_0 , or $\overline{CE1}r$ Low to High transition.

3. Data Retention Low Vccr Characteristics (FCRAM)

Parameter	Symbol	Test Conditions	Value		Unit
Farameter	Symbol	rest conditions		Max	Offic
Vccr Data Retention Supply Voltage	V _{DR}	$\overline{\frac{\text{CE1r}}{\text{CE1r}}} = \text{CE2r} \ge \text{V}_{\text{CCF}} - 0.2 \text{ V or,}$ $\overline{\text{CE1r}} = \text{CE2r} = \text{V}_{\text{IH}}$		3.1	٧
Vccr Data Retention Supply Current	ldr			1.5	mA
	I _{DR1}	$ \begin{array}{l} 2.1 \text{ V} \leq \text{Vccr} \leq 2.7 \text{ V}, \\ \text{V}_{\text{IN}} \leq 0.2 \text{ V or V}_{\text{IN}} \geq \text{Vccr} - 0.2 \text{ V}, \\ \hline \overline{\text{CE1}} r = \text{CE2} r \geq \text{Vccr} - 0.2 \text{ V}, \text{ lout=0 mA} \\ \end{array} $	_	100	μА
Data Retention Setup Time	tors	2.7 V ≤ Vccr ≤ 3.1 V at data retention entry	0	_	ns
Data Retention Recovery Time	t drr	2.7 V ≤ Vccr ≤ 3.1 V after data retention		_	ns
Vccr Voltage Transition Time	ΔV/Δt	_	0.2	_	V/µs

^{* :} $2.0 \text{ V} \le \text{V}_{\text{IH}} \le \text{V}_{\text{CC}} \text{r} + 0.3 \text{ V}$

• Data Retention Timing



■ PIN CAPACITANCE

Parameter	Symbol	Condition	Value			Unit
			Min	Тур	Max	Oiiit
Input Capacitance	Cin	VIN = 0	_	_	20.0	pF
Output Capacitance	Соит	Vоит = 0	_	_	25.0	pF
Control Pin Capacitance	C _{IN2}	V _{IN} = 0	_	_	25.0	рF

Note: Test conditions $T_A = +25$ °C, f = 1.0 MHz

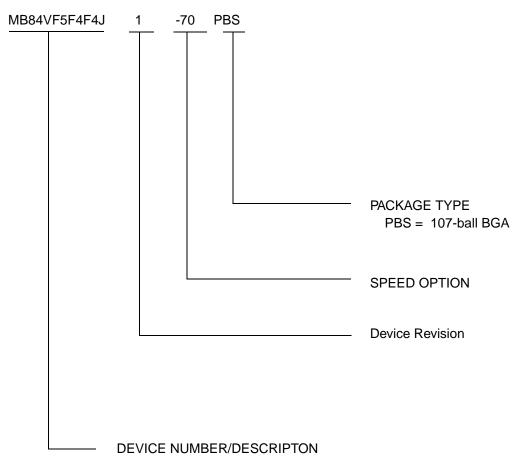
■ HANDLING OF PACKAGE

Please handle this package carefully since the sides of package create acute angles.

■ CAUTION

- The high voltage (V_{ID}) cannot apply to address pins and control pins except RESET. Exception is when autoselect and sector group protect function are used, then the high voltage (V_{ID}) can be applied to RESET.
- Without the high voltage (V_{ID}), sector group protection can be achieved by using "Extended Sector Group Protection" command.

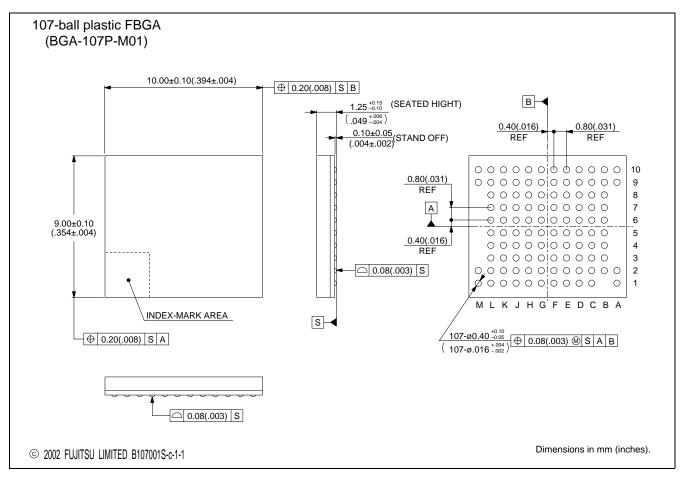
■ ORDERING INFORMATION



64Mega-bit (4M x 16bit) Dual Operation Flash Memory 32Mega-bit (4M x 16bit) Dual Operation Flash Memory 3.0 V-only Read, Program, and Erase

32Mega-bit (2M x 16bit) FCRAM

■ PACKAGE DIMENSION



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